

Module Configuration

VT Part Number	Capacity	Module Configuration	Device Configuration	Device Package	Module Ranks	Performance	CAS Latency
VR7EA567294FBZ	2GB	256Mx72	256Mx4 (18)	TFBGA	1	PC3-6400	CL6 (6-6-6)
VR7EA567294FBA	2GB	256Mx72	256Mx4 (18)	TFBGA	1	PC3-8500	CL7 (7-7-7)
VR7EA567294FBD	2GB	256Mx72	256Mx4 (18)	TFBGA	1	PC3-10600	CL9 (9-9-9)
VR7EA567294FBF	2GB	256Mx72	256Mx4 (18)	TFBGA	1	PC3-12800	CL11 (11-11-11)
VR7EA567294FBG	2GB	256Mx72	256Mx4 (18)	TFBGA	1	PC3-14900	CL13 (13-13-13)
VR7EA127294GBZ	4GB	512Mx72	512Mx4 (18)	TFBGA	1	PC3-6400	CL6 (6-6-6)
VR7EA127294GBA	4GB	512Mx72	512Mx4 (18)	TFBGA	1	PC3-8500	CL7 (7-7-7)
VR7EA127294GBD	4GB	512Mx72	512Mx4 (18)	TFBGA	1	PC3-10600	CL9 (9-9-9)
VR7EA127294GBF	4GB	512Mx72	512Mx4 (18)	TFBGA	1	PC3-12800	CL11 (11-11-11)
VR7EA127294GBG	4GB	512Mx72	512Mx4 (18)	TFBGA	1	PC3-14900	CL13 (13-13-13)
VR7EA127294FBZ	4GB	512Mx72	256Mx4 (36)	TFBGA	2	PC3-6400	CL6 (6-6-6)
VR7EA127294FBA	4GB	512Mx72	256Mx4 (36)	TFBGA	2	PC3-8500	CL7 (7-7-7)
VR7EA127294FBD	4GB	512Mx72	256Mx4 (36)	TFBGA	2	PC3-10600	CL9 (9-9-9)
VR7EA127294FBF	4GB	512Mx72	256Mx4 (36)	TFBGA	2	PC3-12800	CL11 (11-11-11)
VR7EA127294FBG	4GB	512Mx72	256Mx4 (36)	TFBGA	2	PC3-14900	CL13 (13-13-13)
VR7EA1G7294HBZ	8GB	1Gx72	1024Mx4 (18)	TFBGA	1	PC3-6400	CL6 (6-6-6)
VR7EA1G7294HBA	8GB	1Gx72	1024Mx4 (18)	TFBGA	1	PC3-8500	CL7 (7-7-7)
VR7EA1G7294HBD	8GB	1Gx72	1024Mx4 (18)	TFBGA	1	PC3-10600	CL9 (9-9-9)
VR7EA1G7294HBF	8GB	1Gx72	1024Mx4 (18)	TFBGA	1	PC3-12800	CL11 (11-11-11)
VR7EA1G7294HBG	8GB	1Gx72	1024Mx4 (18)	TFBGA	1	PC3-14900	CL13 (13-13-13)
VR7EA1G7294GBZ	8GB	1Gx72	512Mx4 (36)	TFBGA	2	PC3-6400	CL6 (6-6-6)
VR7EA1G7294GBA	8GB	1Gx72	512Mx4 (36)	TFBGA	2	PC3-8500	CL7 (7-7-7)
VR7EA1G7294GBD	8GB	1Gx72	512Mx4 (36)	TFBGA	2	PC3-10600	CL9 (9-9-9)
VR7EA1G7294GBF	8GB	1Gx72	512Mx4 (36)	TFBGA	2	PC3-12800	CL11 (11-11-11)
VR7EA1G7294GBG	8GB	1Gx72	512Mx4 (36)	TFBGA	2	PC3-14900	CL13 (13-13-13)
VR7EA2G7294HBZ	16GB	2Gx72	1024Mx4 (36)	TFBGA	2	PC3-6400	CL6 (6-6-6)
VR7EA2G7294HBA	16GB	2Gx72	1024Mx4 (36)	TFBGA	2	PC3-8500	CL7 (7-7-7)
VR7EA2G7294HBD	16GB	2Gx72	1024Mx4 (36)	TFBGA	2	PC3-10600	CL9 (9-9-9)
VR7EA2G7294HBF	16GB	2Gx72	1024Mx4 (36)	TFBGA	2	PC3-12800	CL11 (11-11-11)
VR7EA2G7294HBG	16GB	2Gx72	1024Mx4 (36)	TFBGA	2	PC3-14900	CL13 (13-13-13)
VR7EA4G7294HHZ	32GB	4Gx72	1024Mx4 (72)	BGA stack	4	PC3-6400	CL6 (6-6-6)
VR7EA4G7294HHA	32GB	4Gx72	1024Mx4 (72)	BGA stack	4	PC3-8500	CL7 (7-7-7)
VR7EA4G7294HHD	32GB	4Gx72	1024Mx4 (72)	BGA stack	4	PC3-10600	CL9 (9-9-9)
VR7EA4G7294HHF	32GB	4Gx72	1024Mx4 (72)	BGA stack	4	PC3-12800	CL11 (11-11-11)
VR7EA4G7294HEZ	32GB	4Gx72	1024Mx4 (72)	DDP	4	PC3-6400	CL6 (6-6-6)
VR7EA4G7294HEA	32GB	4Gx72	1024Mx4 (72)	DDP	4	PC3-8500	CL7 (7-7-7)
VR7EA4G7294HED	32GB	4Gx72	1024Mx4 (72)	DDP	4	PC3-10600	CL9 (9-9-9)
VR7EA4G7294HEF	32GB	4Gx72	1024Mx4 (72)	DDP	4	PC3-12800	CL11 (11-11-11)

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Features

- JEDEC standard Power Supply
 - VDD = 1.35V (1.283 to 1.45V) & 1.5V (1.425 to 1.575V)
 - VDDSPD = +3.0V to +3.6V
 - Backward Compatible with 1.5V DDR3 DIMMs
 - VDD = 1.5V (1.425V to 1.575V)
- 240-pin Registered Dual-In-Line Memory Module with parity bit for address and control bus.
- 8 Internal Banks.
- Programmable CAS Latency: 6, 7, 8, 9, 10, 11
- Programmable CAS Write Latency (CWL).
- Programmable Additive Latency (Posted CAS).
- Fixed burst chop (BC) of 4 and burst length (BL) of 8 via the mode register set (MRS)
- Selectable BC4 or BL8 on-the-fly (OTF)
- On-Die-Termination (ODT) and Dynamic ODT for improved signal integrity.
- Refresh, Self Refresh and Power Down Modes.
- ZQ Calibration for output driver and ODT.
- System Level Timing Calibration Support via Write Leveling and Multi Purpose Register (MPR) Read Pattern.
- Serial Presence Detect with EEPROM.
- On-DIMM Thermal Sensor.
- Asynchronous Reset.
- LP RDIMM dimensions: 133.35 mm x 30 mm.
- 2/4 rank modules include heat spreader.
- RoHS Compliant* (see last page)

Nomenclature

Module Standard	SDRAM Standard	Clock
PC3-6400	DDR3-800	400MHz
PC3-8500	DDR3-1066	533MHz
PC3-10600	DDR3-1333	667MHz
PC3-12800	DDR3-1600	800MHz
PC3-14920	DDR3-1866	933MHz

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PIN CONFIGURATIONS

Pin	Front Side	Pin	Back Side	Pin	Front Side	Pin	Back Side	Pin	Front Side	Pin	Back Side	Pin	Front Side	Pin	Back Side
1	VREFDQ	121	VSS	31	DQ25	151	VSS	61	A2	181	A1	91	DQ41	211	VSS
2	VSS	122	DQ4	32	VSS	152	DQS12, TDQS12	62	VDD	182	VDD	92	VSS	212	DQS14, TDQS14
3	DQ0	123	DQ5	33	DQS3#	153	DQS12#, TDQS12#	63	CK1	183	VDD	93	DQS5#	213	DQS14#, TDQS14#
4	DQ1	124	VSS	34	DQS3	154	VSS	64	CK1#	184	CK0	94	DQS5	214	VSS
5	VSS	125	DQS9, TDQS9	35	VSS	155	DQ30	65	VDD	185	CK0#	95	VSS	215	DQ46
6	DQS0#	126	DQS9#, TDQS9#	36	DQ26	156	DQ31	66	VDD	186	VDD	96	DQ42	216	DQ47
7	DQS0	127	VSS	37	DQ27	157	VSS	67	VREFCA	187	EVENT#, NC	97	DQ43	217	VSS
8	VSS	128	DQ6	38	VSS	158	CB4	68	Par_In	188	A0	98	VSS	218	DQ52
9	DQ2	129	DQ7	39	CB0	159	CB5	69	VDD	189	VDD	99	DQ48	219	DQ53
10	DQ3	130	VSS	40	CB1	160	VSS	70	A10 / AP	190	BA1	100	DQ49	220	VSS
11	VSS	131	DQ12	41	VSS	161	DQS17, TDQS17	71	BA0	191	VDD	101	VSS	221	DQS15, TDQS15
12	DQ8	132	DQ13	42	DQS8#	162	DQS17#, TDQS17#	72	VDD	192	RAS#	102	DQS6#	222	DQS15#, TDQS15#
13	DQ9	133	VSS	43	DQS8	163	VSS	73	WE#	193	S0#	103	DQS6	223	VSS
14	VSS	134	DQS10, TDQS10	44	VSS	164	CB6	74	CAS#	194	VDD	104	VSS	224	DQ54
15	DQS1#	135	DQS10#, TDQS10#	45	CB2	165	CB7	75	VDD	195	ODT0	105	DQ50	225	DQ55
16	DQS1	136	VSS	46	CB3	166	VSS	76	S1#	196	A13	106	DQ51	226	VSS
17	VSS	137	DQ14	47	VSS	167	NC(TEST)	77	ODT1	197	VDD	107	VSS	227	DQ60
18	DQ10	138	DQ15	48	VTT	168	RESET#	78	VDD	198	S3#	108	DQ56	228	DQ61
19	DQ11	139	VSS	KEY				79	S2#	199	VSS	109	DQ57	229	VSS
20	VSS	140	DQ20	49	VTT	169	CKE1	80	VSS	200	DQ36	110	VSS	230	DQS16, TDQS16
21	DQ16	141	DQ21	50	CKE0	170	VDD	81	DQ32	201	DQ37	111	DQS7#	231	DQS16#, TDQS16#
22	DQ17	142	VSS	51	VDD	171	A15	82	DQ33	202	VSS	112	DQS7	232	VSS
23	VSS	143	DQS11, TDQS11	52	BA2	172	A14	83	VSS	203	DQS13, TDQS13	113	VSS	233	DQ62
24	DQS2#	144	DQS11#, TDQS11#	53	Err_Out#	173	VDD	84	DQS4#	204	DQS13#, TDQS13#	114	DQ58	234	DQ63
25	DQS2	145	VSS	54	VDD	174	A12 / BC#	85	DQS4	205	VSS	115	DQ59	235	VSS
26	VSS	146	DQ22	55	A11	175	A9	86	VSS	206	DQ38	116	VSS	236	VDDSPD
27	DQ18	147	DQ23	56	A7	176	VDD	87	DQ34	207	DQ39	117	SA0	237	SA1
28	DQ19	148	VSS	57	VDD	177	A8	88	DQ35	208	VSS	118	SCL	238	SDA
29	VSS	149	DQ28	58	A5	178	A6	89	VSS	209	DQ44	119	SA2	239	VSS
30	DQ24	150	DQ29	59	A4	179	VDD	90	DQ40	210	DQ45	120	VTT	240	VTT
				60	VDD	180	A3								

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PIN FUNCTION DESCRIPTION

SYMBOL	TYPE	POLARITY	DESCRIPTION
CK0	IN	Positive Edge	Positive line of the differential pair of system clock inputs that drives input to the on-DIMM Clock Driver.
/CK0	IN	Negative Edge	Negative line of the differential pair of system clock inputs that drives the input to the on-DIMM Clock Driver.
CKE[1:0]	IN	Active High	CKE HIGH activates, and CKE LOW deactivates internal clock signals, and device input buffers and output drivers of the SDRAMs. Taking CKE LOW provides PRECHARGE POWER-DOWN and SELF REFRESH operation (all banks idle), or ACTIVE POWER DOWN (row ACTIVE in any bank)
S[3:0]#	IN	Active Low	Enables the associated SDRAM command decoder when low and disables decoder when high. When decoder is disabled, new commands are ignored and previous operations continue. These input signals also disable all outputs (except CKE and ODT) of the register(s) on the DIMM when both inputs are high. When both S[1:0] are high, all register outputs (except CKE, ODT and Chip select) remain in the previous state. For modules supporting 4 ranks, S[3:2] operate similarly to S[1:0] for a second set of register outputs.
ODT[1:0]	IN	Active High	On-Die Termination control signals
RAS#, CAS#, WE#	IN	Active Low	When sampled at the positive rising edge of the clock, CAS#, RAS#, and WE# define the operation to be executed by the SDRAM.
VREFDQ	Supply		Reference voltage for DQ0-DQ63 and CB0-CB7.
VREFCA	Supply		Reference voltage for A0-A15, BA0-BA2, RAS#, CAS#, WE#, S0#, S1#, CKE0, CKE1, Par_In, ODT0 and ODT1.
BA[2:0]	IN	-	Selects which SDRAM bank of eight is activated. BA0 - BA2 define to which bank an Active, Read, Write or Precharge command is being applied. Bank address also determines mode register is to be accessed during an MRS cycle.
A[15:13, 12/BC, 11, 10/AP, 9:0]	IN	-	Provided the row address for Active commands and the column address and Auto Precharge bit for Read/Write commands to select one location out of the memory array in the respective bank. A10 is sampled during a Precharge command to determine whether the Precharge applies to one bank (A10 LOW) or all banks (A10 HIGH). If only one bank is to be precharged, the bank is selected by BA. A12 is also utilized for BL 4/8 identification for "BL on the fly" during CAS# command. The address inputs also provide the op-code during Mode Register Set commands.
DQ [63:0], CB [7:0]	I/O	-	Data and Check Bit Input/Output pins
VDD, VSS	Supply	-	Power and ground for the DDR SDRAM input buffers and core logic.
DM [8:0]	IN	Active High	Masks write data when high, issued concurrently with input data.
VDD, VSS	Supply		Power and ground for the DDR SDRAM input buffers and core logic.
VTT	Supply		Termination Voltage for Address/Command/Control/Clock nets.
DQS[17:0]	I/O	Positive Edge	Positive line of the differential data strobe for input and output data.
DQS [17:0]#	I/O	Negative Edge	Negative line of the differential data strobe for input and output data.
TDQS[17:9], TDQS[17:9]#	OUT		TDQS, TDQS# is applicable for X8 DRAMs only. When enabled via Mode Register A11=1 in MR1, DRAM will enable the same termination resistance function on TDQS, TDQS# that is applied to DQS, DQS#. When disabled via mode register A11=0 in MR1, DM, TDQS will provide the data mask function and TDQS# is not used. X4/X16 DRAMs must disable the TDQS function via mode register A11=0 in MR1
SA [2:0]	IN	-	These signals are tied at the system planar to either VSS or VDDSPD to configure the serial SPD EEPROM address range.
SDA	I/O	-	This bidirectional pin is used to transfer data into or out of the SPD EEPROM. A resistor must be connected from the SDA bus line to VDDSPD on the system planar to act as a pull-up.
SCL	IN	-	This signal is used to clock data into and out of the SPD EEPROM. A resistor may be connected from the SCL bus time to VDDSPD on the system planar to act as a pull-up.

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PIN FUNCTION DESCRIPTION

SYMBOL	TYPE	POLARITY	DESCRIPTION
EVENT#	OUT (open drain)	Active Low	This signal indicates that a thermal event has been detected in the thermal sensing device. The system should guarantee the electrical level requirement is met for the EVENT pin on TS/SPD part.
VDDSPD	Supply	-	Serial EEPROM positive power supply wired to a separate power pin at the connector which supports from 3.0 Volt to 3.6 Volt (nominal 3.3V) operation.
RESET#	IN		The RESET pin is connected to the RST pin on the register and to the OE pin on the PLL. When low, all register outputs will be driven low and the PLL clocks to the DRAMs and register(s) will be set to low level (the PLL will remain synchronized with the input clock)
Par_In	IN		Parity bit for the Address and Control bus. ("1 ": Odd, "0 ": Even)
Err_Out#	OUT		Parity error found in the Address and Control bus
TEST			Used by memory bus analysis tools (unused (NC) on memory DIMMs)

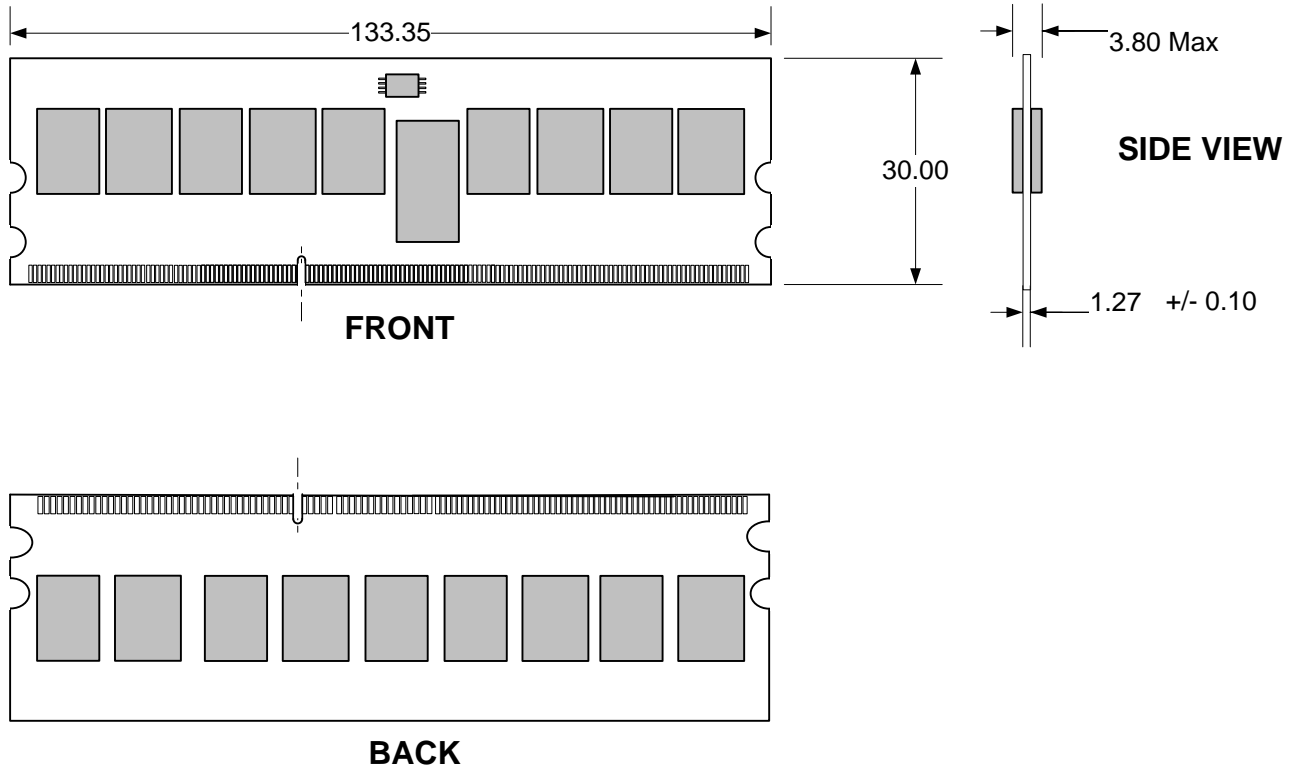
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MECHANICAL OUTLINE SINGLE RANK

Dimensions are in mm. (Tolerance is +/- 0.127, unless otherwise stated.)



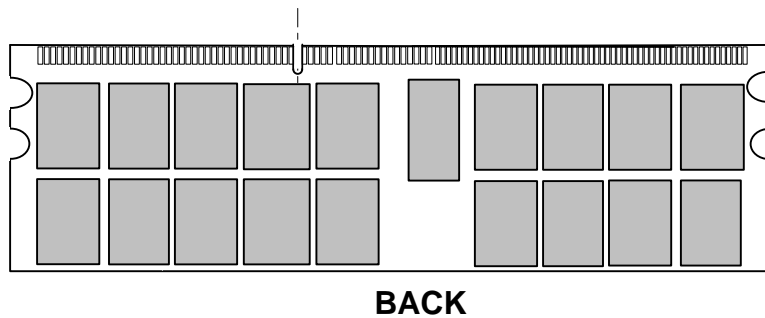
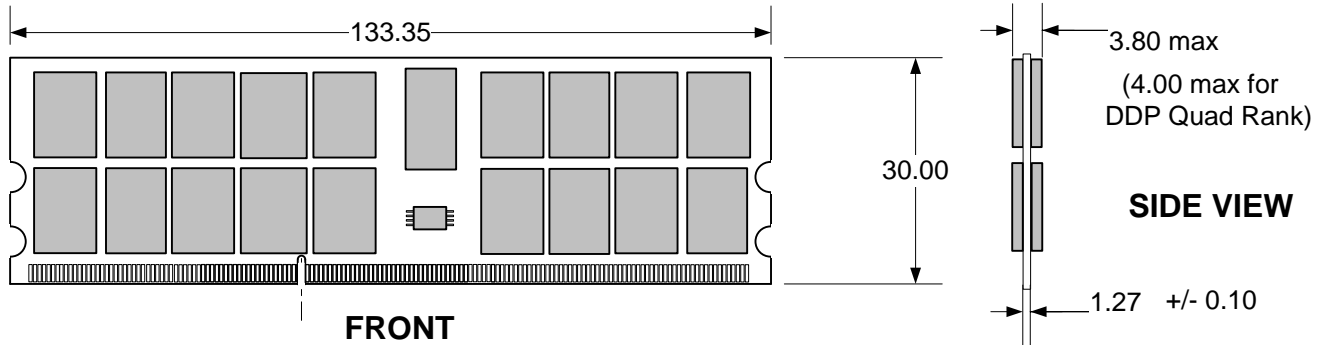
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MECHANICAL OUTLINE DUAL and DDP QUAD RANK

Dimensions are in mm. (Tolerance is +/- 0.127, unless otherwise stated.)



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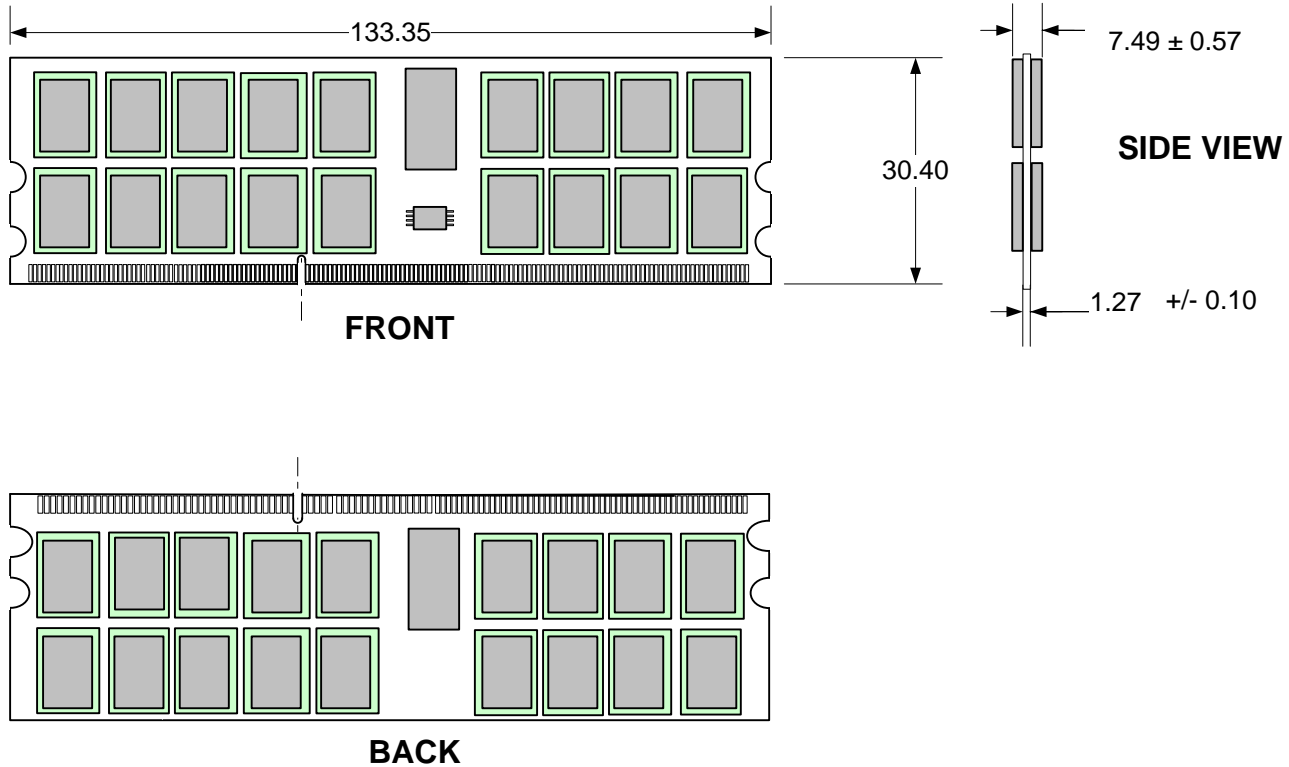
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MECHANICAL OUTLINE QUAD RANK BGA Stack

Dimensions are in mm. (Tolerance is +/- 0.127, unless otherwise stated.)

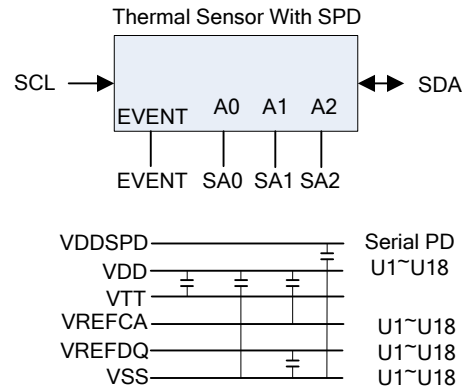
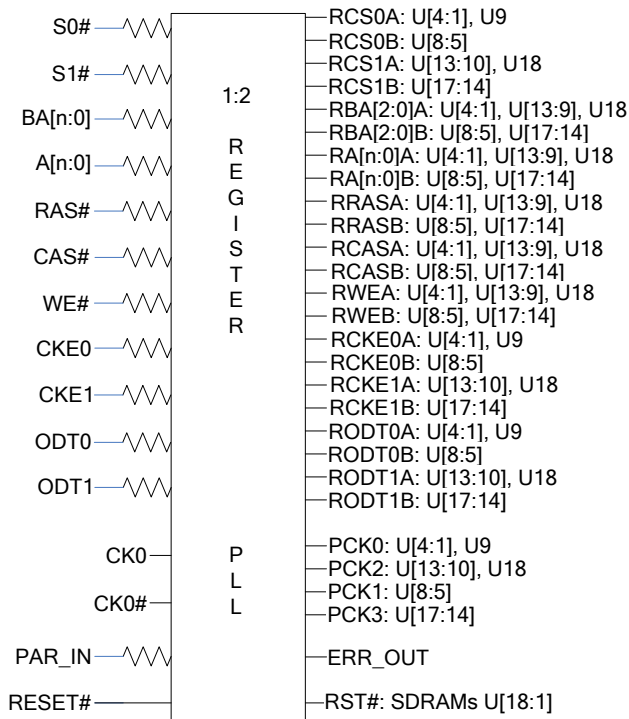


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FUNCTIONAL BLOCK DIAGRAM SINGLE RANK



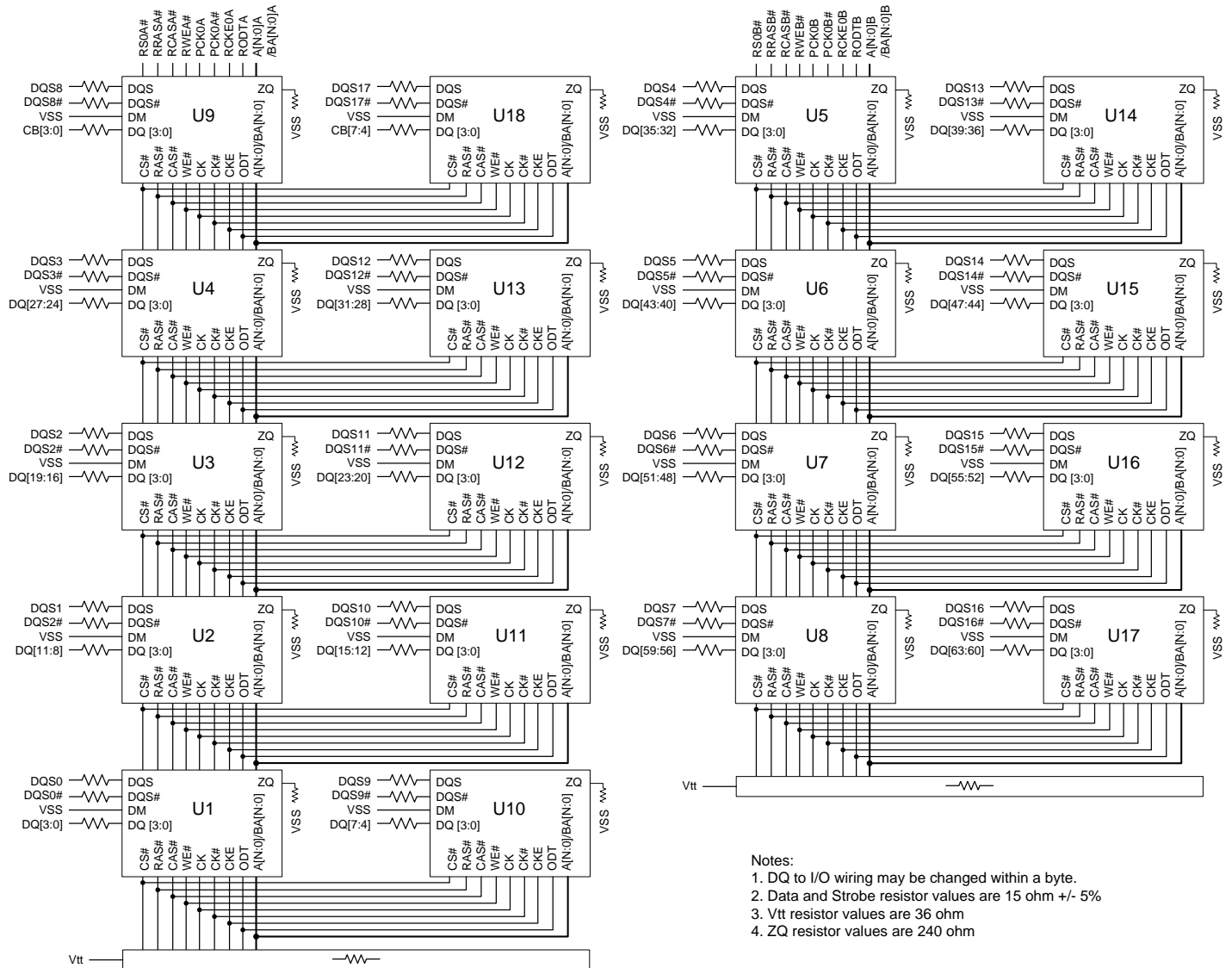
Notes:
The resistor values may vary depending on systems application

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FUNCTIONAL BLOCK DIAGRAM SINGLE RANK



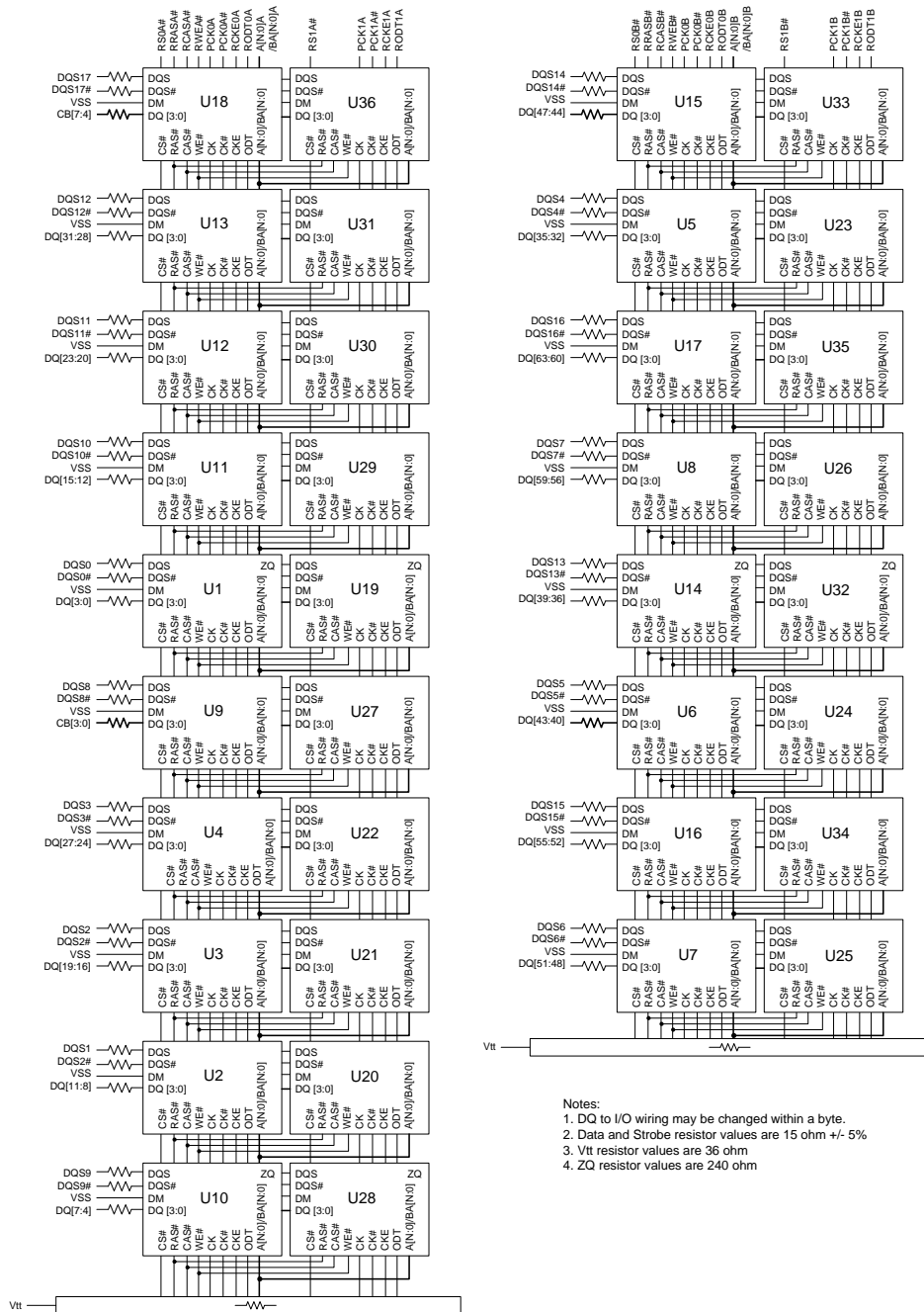
- Notes:
1. DQ to I/O wiring may be changed within a byte.
 2. Data and Strobe resistor values are 15 ohm +/- 5%
 3. Vtt resistor values are 36 ohm
 4. ZQ resistor values are 240 ohm

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FUNCTIONAL BLOCK DIAGRAM DUAL RANK



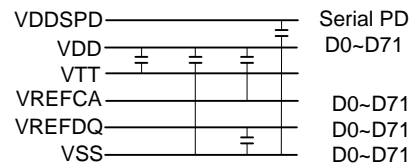
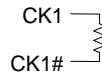
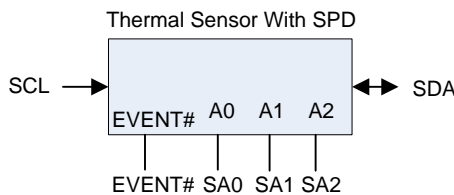
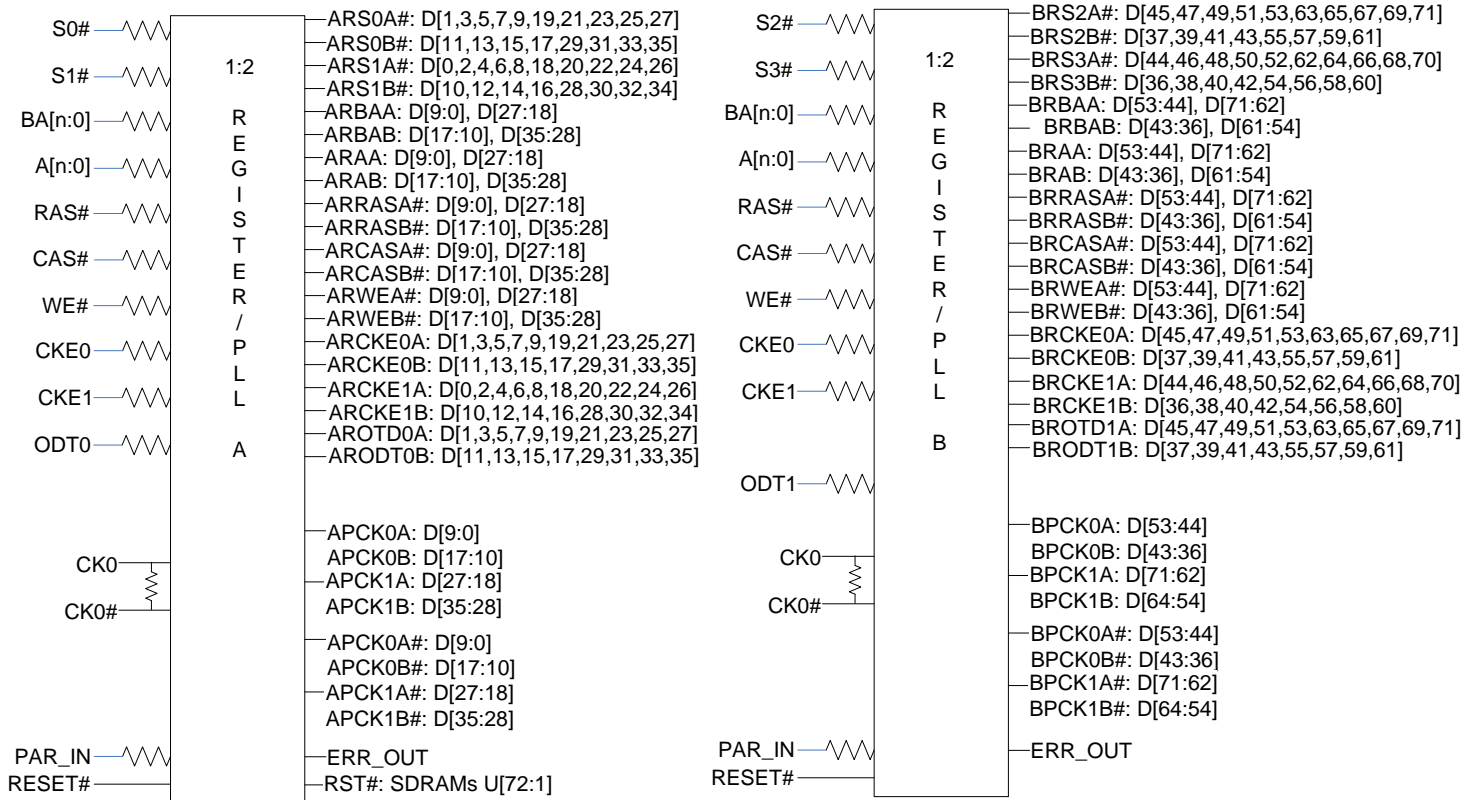
- Notes:
1. DQ to I/O wiring may be changed within a byte.
 2. Data and Strobe resistor values are 15 ohm +/- 5%
 3. Vtt resistor values are 36 ohm
 4. ZQ resistor values are 240 ohm

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FUNCTIONAL BLOCK DIAGRAM QUAD RANK



Notes:

1. The resistor values may vary depending on systems application
2. CK0 and CK0# are differentially terminated with single 120Ω resistor.
3. CK1 and CK1# are differentially terminated with single 120Ω resistor but is not used.
4. Unused register inputs ODT1 for register A and ODT0 for register B are tied to GND.

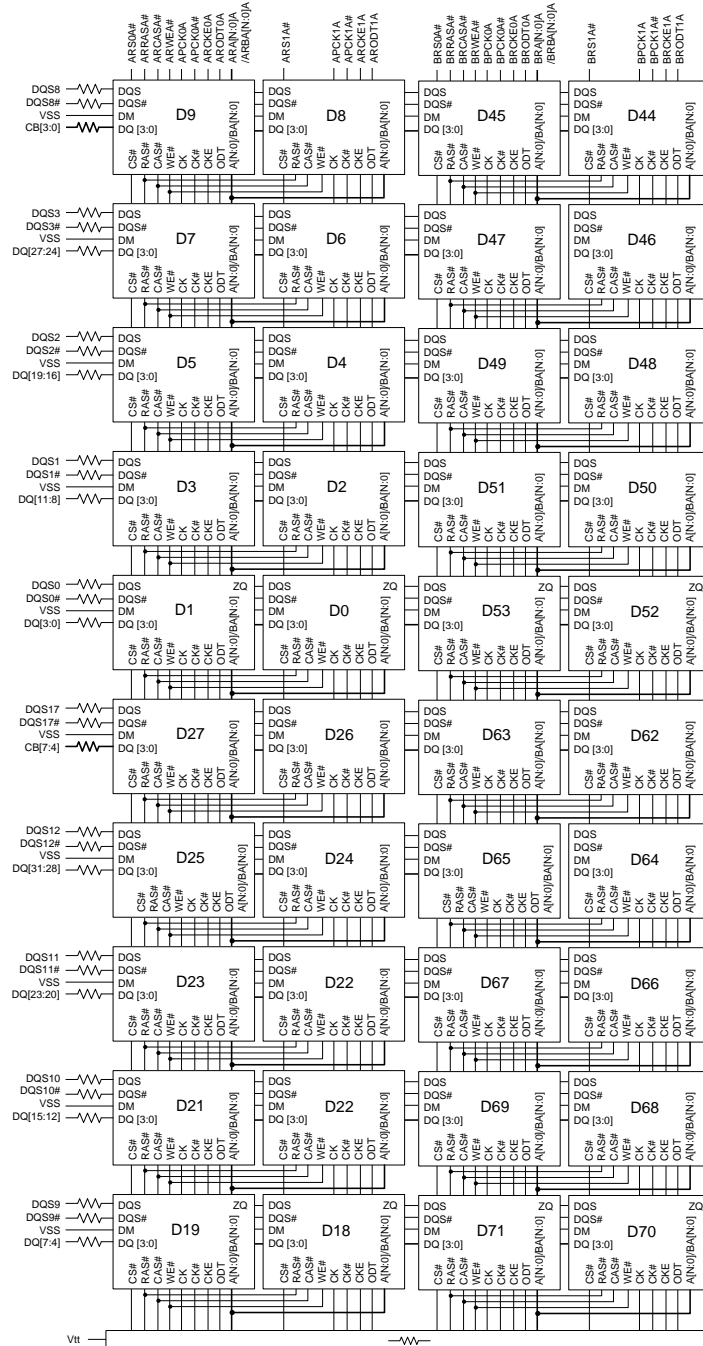
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ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Voltage on any pin relative to GND	Vin, Vout	-0.4 ~ 1.975	V
Voltage on VDD supply relative to GND	VDD	-0.4 ~ 1.975	V
Voltage on VDDQ supply relative to GND	VDDQ	-0.4 ~ 1.975	V
Storage temperature	TSTG	-55 ~ +100	°C

Note: Permanent device damage may occur if 'ABSOLUTE MAXIMUM RATINGS' are exceeded. Functional operation should be restricted to recommended operating condition. Exposure to higher than recommended voltage for extended periods of time could affect device reliability.

DC OPERATING CONDITIONS AND CHARACTERISTICS (SSTL_1.5)

Recommended operating conditions (Voltages referenced to GND, Tcase = 0 to 85°C)

Parameter	Symbol	Min.	Max.	Unit	Notes
Case Temperature	Tcase	0	95	°C	5
Supply voltage @ 1.35V	VDD	1.283	1.45	V	1, 2
Supply voltage for DQ, DQS @ 1.35V	VDDQ	1.283	1.45	V	1, 2
Supply voltage @ 1.5V	VDD	1.425	1.575	V	1, 2
Supply voltage for DQ, DQS @ 1.5V	VDDQ	1.425	1.575	V	1, 2
Reference Voltage for DQ, DM inputs	VREFDQ(DC)	0.49 x VDD	0.51 x VDD	V	3, 4
Reference Voltage for ADD, CMD inputs	VREFCA(DC)	0.49 x VDD	0.51 x VDD	V	3, 4
Terminal Voltage	VTT	0.49 x VDD	0.51 x VDD	V	3, 4
EEPROM Supply Voltage	VDDSPD	1.7	3.6	V	
Input high voltage	VIH(AC)	VREF + 0.175	-	V	
	VIH(DC)	VREF + 0.100	VDD		
Input low voltage	VIL(AC)	-	VREF - 0.175	V	
	VIL(DC)	VSS	VREF - 0.100		
Input leakage current	Single Rank	IIL	-5	5	µA
Output leakage current	Single Rank	IOL	-5	5	µA
Input leakage current	Dual Rank	IIL	-5	5	µA
Output leakage current	Dual Rank	IOL	-10	10	µA

Note:

- VDDQ tracks with VDD. AC parameters are measured with VDD and VDDQ tied together
- Under all conditions VDDQ must be less than or equal to VDD.
- The ac peak noise on VREF may not allow VREF to deviate from VREF.DC by more than ±1% VDD (for reference: approx. ± 15 mV).
- For reference: approx. VDD/2 ± 15 mV.
- Refresh rate required to be doubled (tREFI = 3.9µs) when 85°C < TC < 95°C.

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DEVICE CAPACITANCE

Parameter	Symbol	DDR3-800		DDR3-1066		DDR3-1333		Units	Notes
		Min	Max	Min	Max	Min	Max		
Input/output capacitance (DQ, DM, DQS, DQS#, TDQS,TDQS#)	CIO	1.5	3.0	1.5	2.7	1.5	2.5	pF	1,2,3
Input capacitance, CK and CK#	CCK	0.8	1.6	0.8	1.6	0.8	1.4	pF	2,3
Input capacitance delta, CK and CK#	CDCK	0	0.15	0	0.15	0	0.15	pF	2,3,4
Input/output capacitance delta DQS and DQS#	CDDQS	0	0.2	0	0.2	0	0.15	pF	2,3,5
Input capacitance, (CTRL, ADD, CMD input-only pins)	CI	0.75	1.4	0.75	1.35	0.75	1.3	pF	2,3,6
Input/output capacitance of ZQ pin	CZQ	-	3	-	3	-	3	pF	2,3,7

DEVICE CAPACITANCE (Cont.)

Parameter	Symbol	DDR3-1600		DDR3-1866		Min	Max	Units	Notes
		Min	Max	Min	Max				
Input/output capacitance (DQ, DM, DQS, DQS#, TDQS,TDQS#)	CIO	1.5	2.3	1.4	2.2			pF	1,2,3
Input capacitance, CK and CK#	CCK	0.8	1.4	0.8	1.3			pF	2,3
Input capacitance delta, CK and CK#	CDCK	0	0.15	0	0.15			pF	2,3,4
Input/output capacitance delta DQS and DQS#	CDDQS	0	0.15	0	0.15			pF	2,3,5
Input capacitance, (CTRL, ADD, CMD input-only pins)	CI	0.75	1.3	0.75	1.2			pF	2,3,6
Input/output capacitance of ZQ pin	CZQ	-	3	-	3			pF	2,3,7

Note:

1. Although the DM, TDQS and TDQS# pins have different functions, the loading matches DQ and DQS
2. This parameter is not subject to production test. It is verified by design and characterization. The capacitance is measured according to JEP147("PROCEDURE FOR MEASURING INPUT CAPACITANCE USING A VECTOR NETWORK ANALYZER(VNA)") with VDD, VDDQ, VSS, VSSQ applied and all other pins floating (except the pin under test, CKE, RESET# and ODT as necessary). VDD=VDDQ=1.5V, VBIAS=VDD/2 and on die termination off.
3. This parameter applies to monolithic devices only; stacked/dual-die devices are not covered here
4. Absolute value of CCK-CCK#
5. Absolute value of CIO(DQS)-CIO(DQS#)
6. CI applies to ODT, CS#, CKE, A0-A15, BA0-BA2, RAS#, CAS#, WE#.
7. Maximum external load capacitance on ZQ pin: 5 pF.

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DC CHARACTERISTICS DEFINITIONS (Recommended operating conditions unless otherwise noted, Tcase = 0 to 85 °C)

Symbol	Conditions	Units	Notes
IDD0	Operating one bank active-precharge current; tCK = tCK(IDD), tRC = tRC(IDD), tRAS = tRASmin(IDD); CKE is HIGH, CS is HIGH between valid commands; Address bus inputs are SWITCHING; Data bus inputs are SWITCHING	mA	1, 2
IDD1	Operating one bank active-read-precharge current; IOUT = 0mA; BL = 8, CL = CL(IDD), AL = 0; tCK = tCK(IDD), tRC = tRC(IDD), tRAS = tRASmin(IDD), tRCD = tRCD(IDD); CKE is HIGH, CS is HIGH between valid commands; Address bus inputs are SWITCHING; Data pattern is same as IDD4W	mA	1, 2
IDD2P-S	Precharge power-down current (slow exit); All banks idle; tCK = tCK(IDD); CKE is LOW; Other control and address bus inputs are STABLE; Data bus inputs are FLOATING	mA	1, 3
IDD2P-F	Precharge power-down current (fast exit); All banks idle; tCK = tCK(IDD); CKE is LOW; Other control and address bus inputs are STABLE; Data bus inputs are FLOATING	mA	1, 3
IDD2Q	Precharge quiet standby current; All banks idle; tCK = tCK(IDD); CKE is HIGH, CS is HIGH; Other control and address bus inputs are STABLE; Data bus inputs are FLOATING	mA	1, 3
IDD2N	Precharge standby current; All banks idle; tCK = tCK(IDD); CKE is HIGH, CS is HIGH; Other control and address bus inputs are SWITCHING; Data bus inputs are SWITCHING	mA	1, 3
IDD3P	Active power-down current; All banks open; tCK = tCK(IDD); CKE is LOW; Other control and address bus inputs are STABLE; Data bus inputs are FLOATING	mA	1, 3
IDD3N	Active standby current; All banks open; tCK = tCK(IDD), tRAS = tRASmax(IDD), tRP = tRP(IDD); CKE is HIGH, CS is HIGH between valid commands; Other control and address bus inputs are SWITCHING; Data bus inputs are SWITCHING	mA	1, 3
IDD4W	Operating burst write current; All banks open, Continuous burst writes; BL = 8, CL = CL(IDD), AL = 0; tCK = tCK(IDD), tRAS = tRASmax(IDD), tRP = tRP(IDD); CKE is HIGH, CS is HIGH between valid commands; Address bus inputs are SWITCHING; Data bus inputs are SWITCHING	mA	1, 2
IDD4R	Operating burst read current; All banks open, Continuous burst reads, IOUT = 0mA; BL = 8, CL = CL(IDD), AL = 0; tCK = tCK(IDD), tRAS = tRAS-max(IDD), tRP = tRP(IDD); CKE is HIGH, CS is HIGH between valid commands; Address bus inputs are SWITCHING; Data pattern is same as IDD4W	mA	1, 2
IDD5B	Burst refresh current; tCK = tCK(IDD); Refresh command at every tRFC(IDD) interval; CKE is HIGH, CS is HIGH between valid commands; Other control and address bus inputs are SWITCHING; Data bus inputs are SWITCHING	mA	1, 3
IDD6	Self refresh current; CK and CK at 0V; CKE ≤ 0.2V; Other control and address bus inputs are FLOATING; Data bus inputs are FLOATING	mA	1, 3
IDD6ET	Extended Temperature Range Self-Refresh Current; CK and CK at 0V; CKE ≤ 0.2V; Other control and address inputs are FLOATING; Data Bus inputs are FLOATING, PASR disabled, Applicable for MR2 setting A6=0 and A7=1	mA	1, 3
IDD7	Operating bank interleave read current; All bank interleaving reads, IOUT = 0mA; BL = 8, CL = CL(IDD), AL = tRCD(IDD)-1*tCK(IDD); tCK = tCK(IDD), tRC = tRC(IDD), tRRD = tRRD(IDD), tRCD = 1*tCK(IDD); CKE is HIGH, CS is HIGH between valid commands; Address bus inputs are STABLE during DESELECTs; Data pattern is same as IDD4R;	mA	1, 2

Notes:

- 1) Calculated values are from component data.
- 2) One module rank in the active IDD; the other ranks in IDD2P-S (slow exit)
- 3) All ranks in this IDD condition.

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IDD

DC CHARACTERISTICS CURRENTS SINGLE RANK 1Gbit

Symbol	DDR3-800	DDR3-1066	DDR3-1333	DDR3-1600	DDR3-1866	Unit
IDD0	1170	1350	1530	1668	1819	mA
IDD1	1530	1710	1890	2035	2191	mA
IDD2P-S	180	180	180	180	180	mA
IDD2P-F	450	450	450	450	450	mA
IDD2Q	720	810	900	1000	1111	mA
IDD2N	810	900	990	1089	1198	mA
IDD3P	450	540	630	735	858	mA
IDD3N	900	990	1080	1178	1285	mA
IDD4R	2340	2880	3600	4447	5494	mA
IDD4W	2340	2880	3420	4025	4737	mA
IDD5B	3600	3960	4320	4713	5142	mA
IDD6	108	108	108	108	108	mA
IDD6ET	162	162	162	162	162	mA
IDD7	4140	4500	5670	7088	8860	mA

DC CHARACTERISTICS CURRENTS SINGLE RANK 2Gbit

Symbol	DDR3-800	DDR3-1066	DDR3-1333	DDR3-1600	DDR3-1866	Unit
IDD0	1260	1620	1800	1963	2140	mA
IDD1	1800	2070	2340	2519	2712	mA
IDD2P-S	180	180	180	180	180	mA
IDD2P-F	450	450	450	450	450	mA
IDD2Q	900	1080	1260	1400	1556	mA
IDD2N	900	1080	1260	1386	1525	mA
IDD3P	810	900	1080	1260	1470	mA
IDD3N	1170	1350	1620	1768	1929	mA
IDD4R	3150	3600	4140	5115	6319	mA
IDD4W	3510	4050	4590	5402	6358	mA
IDD5B	4950	5220	5490	5989	6534	mA
IDD6	162	162	162	162	162	mA
IDD6ET	216	216	216	216	216	mA
IDD7	5760	6210	7470	9338	11673	mA

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DC CHARACTERISTICS CURRENTS SINGLE RANK 4Gbit

Symbol	DDR3-800	DDR3-1066	DDR3-1333	DDR3-1600	DDR3-1600	Unit
IDD0	888	1330	1350	1472	1605	mA
IDD1	1008	1510	1530	1647	1773	mA
IDD2P-S	294	440	450	450	450	mA
IDD2P-F	294	440	450	450	450	mA
IDD2Q	634	950	960	1067	1186	mA
IDD2N	634	950	970	1067	1174	mA
IDD3P	294	440	540	630	735	mA
IDD3N	721	1080	1180	1288	1405	mA
IDD4R	1215	1820	2010	2483	3067	mA
IDD4W	1195	1790	2070	2436	2867	mA
IDD5B	1776	2660	3210	3502	3821	mA
IDD6	187	280	280	280	280	mA
IDD6ET	187	280	280	280	280	mA
IDD7	1989	2980	3530	4413	5516	mA

DC CHARACTERISTICS CURRENTS DUAL RANK 1Gbit

Symbol	DDR3-800	DDR3-1066	DDR3-1333	DDR3-1600	DDR3-1866	Unit
IDD0	1350	1530	1710	1865	2034	mA
IDD1	1710	1890	2070	2228	2399	mA
IDD2P-S	360	360	360	360	360	mA
IDD2P-F	900	900	900	900	900	mA
IDD2Q	1440	1620	1800	2000	2222	mA
IDD2N	1620	1800	1980	2178	2396	mA
IDD3P	900	1080	1260	1470	1715	mA
IDD3N	1800	1980	2160	2357	2572	mA
IDD4R	2340	2880	3600	4447	5494	mA
IDD4W	2520	3060	3600	4237	4987	mA
IDD5B	7560	8280	9000	9819	10712	mA
IDD6	216	216	216	216	216	mA
IDD6ET	324	324	324	324	324	mA
IDD7	4320	4680	5850	7313	9141	mA

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DC CHARACTERISTICS CURRENTS DUAL RANK 2Gbit

Symbol	DDR3-800	DDR3-1066	DDR3-1333	DDR3-1600	DDR3-1866	Unit
IDD0	1350	1710	1890	2061	2247	mA
IDD1	1890	2160	2430	2616	2816	mA
IDD2P-S	360	360	360	360	360	mA
IDD2P-F	900	900	900	900	900	mA
IDD2Q	1800	2160	2520	2800	3111	mA
IDD2N	1800	2160	2520	2772	3049	mA
IDD3P	1620	1800	2160	2520	2940	mA
IDD3N	2340	2700	3240	3535	3857	mA
IDD4R	3240	3690	4230	5226	6456	mA
IDD4W	3600	4140	4680	5508	6483	mA
IDD5B	9900	10440	10980	11979	13069	mA
IDD6	324	324	324	324	324	mA
IDD6ET	432	432	432	432	432	mA
IDD7	5850	6300	7560	9450	11813	mA

DC CHARACTERISTICS CURRENTS DUAL RANK 4Gbit

(Estimated values)

Symbol	DDR3-800	DDR3-1066	DDR3-1333	DDR3-1600	DDR3-1866	Unit
IDD0	1128	1690	1710	1730	1886	mA
IDD1	1248	1870	1890	200	215	mA
IDD2P-S	474	710	720	750	750	mA
IDD2P-F	474	710	720	750	750	mA
IDD2Q	874	1310	1320	1350	1500	mA
IDD2N	874	1310	1330	1360	1496	mA
IDD3P	474	710	900	930	1085	mA
IDD3N	1021	1530	1720	1750	1909	mA
IDD4R	1455	2180	2370	2580	3187	mA
IDD4W	1435	2150	2430	2640	3107	mA
IDD5B	2016	3020	3570	3600	3928	mA
IDD6	367	550	550	550	550	mA
IDD6ET	367	550	550	550	550	mA
IDD7	2229	3340	3890	4010	5013	mA
IDD8	367	550	550	550	550	mA

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DC CHARACTERISTICS CURRENTS QUAD RANK 2Gbit BGA Stack

Symbol	DDR3-1066	DDR3-1333	Unit
IDD0	3600	3960	mA
IDD1	4320	4680	mA
IDD2P-S	864	864	mA
IDD2P-F	1440	1440	mA
IDD2Q	1800	2160	mA
IDD2N	1800	2160	mA
IDD3P	1080	2160	mA
IDD3N	3240	3600	mA
IDD4R	5760	6840	mA
IDD4W	6480	7920	mA
IDD5B	11880	11880	mA
IDD6	864	864	mA
IDD6ET	1080	1080	mA
IDD7	10800	13320	mA

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DC CHARACTERISTICS CURRENTS QUAD 4Gbit BGA Stack

(Estimated values)

Symbol	DDR3-800	DDR3-1066	DDR3-1333	Unit
IDD0	1934	2898	2934	mA
IDD1	2055	3078	3114	mA
IDD2P-S	925	1386	1404	mA
IDD2P-F	925	1386	1404	mA
IDD2Q	1670	2502	2520	mA
IDD2N	1670	2502	2538	mA
IDD3P	925	1386	1764	mA
IDD3N	1958	2934	3312	mA
IDD4R	2283	3420	3618	mA
IDD4W	2247	3366	3654	mA
IDD5B	2812	4212	4770	mA
IDD6	733	1098	1098	mA
IDD6ET	733	1098	1098	mA
IDD7	3052	4572	5130	mA
IDD8	733	1098	1098	mA

DC CHARACTERISTICS CURRENTS QUAD RANK 8Gbit DDP

(Estimated values)

Symbol	DDR3-1333	DDR3-1600	Unit
IDD0	3420	3460	mA
IDD1	3780	400	mA
IDD2P-S	1440	1500	mA
IDD2P-F	1440	1500	mA
IDD2Q	2640	2700	mA
IDD2N	2660	2720	mA
IDD3P	1800	1860	mA
IDD3N	3440	3500	mA
IDD4R	4740	5160	mA
IDD4W	4860	5280	mA
IDD5B	7140	7200	mA
IDD6	1100	1100	mA
IDD6ET	1100	1100	mA
IDD7	7780	8020	mA
IDD8	1100	1100	mA

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REGISTERING CLOCK DRIVER SPECIFICATIONS AT 1.35V OPERATION

SSTE82882 or equivalent

Symbol	Parameter	Pins	Min	Nom	Max	Units
VDD	DC supply voltage	-	1.283	1.35	1.418	V
VREF	DC reference voltage	-	0.49 x VDD	0.5 x VDD	0.51 x VDD	V
VTT	DC termination voltage	-	VREF - 40 mV	VREF	VREF + 40 mV	V
VIH(AC)	AC high-level input voltage	Control, command, address	VREF + VAC	-	VDD	V
VIL(AC)	AC low-level input voltage	Control, command, address	0	-	VREF - VAC	V
VIH(DC)	DC high-level input voltage	Control, command, address	VREF + VDC	-	VDD	V
VIL(DC)	DC low-level input voltage	Control, command, address	0	-	VREF - VDC	V
VIH (CMOS)	High-level input voltage	RESET#, MIRROR	0.65 x VDD	-	VDD	V
VIL (CMOS)	Low-level input voltage	RESET#, MIRROR	0	-	0.35 x VDD	V
VIX(AC)	Differential input crosspoint voltage range	CK, CK#, FBIN, FBIN#	0.5 x VDD - VXIN	0.5 x VDD	0.5 x VDD + VXIN	V
VID(AC)	Differential input voltage	CK, CK#	350	-	VDD	mV
IOH	High-level output current	FBOUT, FBOUT#	-11	-	-	mA
IOL	Low-level output current	ERR_OUT#	25	-	25	mA

Notes: Timing and switching specifications for the register are critical for proper operation of the DDR3 SDRAM RDIMMs. These are meant to be a subset of the parameters for the specific device used on the module.

AC and DC Voltage Levels

Symbol	Parameter	Value	Unit
VAC	AC input Level	135	mV
VDC	DC input Level	90	mV
VXIN	Input cross point variation Voltage	135	mV

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AC CHARACTERISTICS

Refresh parameters by device density

Parameter	Symbol	1Gb	2Gb	4Gb	8Gb	Units	Notes	
REF command to ACT or REF command time	tRFC	110	160	260	350	ns		
Average periodic refresh interval	tREFI	0 °C ≤ TCASE ≤ 85 °C	7.8	7.8	7.8	7.8	μs	
		85 °C < TCASE ≤ 95 °C	3.9	3.9	3.9	3.9	μs	1

Note: 1) Users should refer to the DRAM supplier data sheet and/or the DIMM SPD to determine if DDR3 SDRAM devices support the following options or requirements referred to in this material.

DDR3-800 Speed Bins and Operating Conditions

Speed Bin		DDR3-800		Unit	Notes	
CL-nRCD-nRP		6-6-6				
Parameter	Symbol	min	max			
Internal read command to first data	tAA	15	20	ns		
ACT to internal read or write delay time	tRCD	15	—	ns		
PRE command period	tRP	15	—	ns		
ACT to ACT or REF command period	tRC	52.5	—	ns		
ACT to PRE command period	tRAS	37.5	9 * tREFI	ns		
CL = 6	CWL = 5	tCK(AVG)	2.5	3.3	ns	1, 2, 3
Supported CL Settings		6		nCK	13	
Supported CWL Settings		5		nCK		

DDR3-1066 Speed Bins and Operating Conditions

Speed Bin		DDR3-1066		Unit	Note	
CL-nRCD-nRP		7-7-7				
Parameter	Symbol	min	max			
Internal read command to first data	tAA	13.125	20	ns		
ACT to internal read or write delay time	tRCD	13.125	—	ns		
PRE command period	tRP	13.125	—	ns		
ACT to ACT or REF command period	tRC	50.625	—	ns		
ACT to PRE command period	tRAS	37.5	9 * tREFI	ns		
CL = 6	CWL = 5	tCK(AVG)	2.5	3.3	ns	1,2,3,6,
	CWL = 6	tCK(AVG)	Reserved		ns	1,2,3,4,
CL = 7	CWL = 5	tCK(AVG)	Reserved		ns	4,
	CWL = 6	tCK(AVG)	1.875	< 2.5	ns	1,2,3,4,
CL = 8	CWL = 5	tCK(AVG)	Reserved		ns	4,
	CWL = 6	tCK(AVG)	1.875	< 2.5	ns	1,2,3,
Supported CL Settings		6, 7, 8		nCK	13	
Supported CWL Settings		5, 6		nCK		

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DDR3-1333 Speed Bins and Operating Conditions

Speed Bin		DDR3-1333		Unit	Note	
CL-nRCD-nRP		9-9-9				
Parameter	Symbol	min	max			
Internal read command to first data	<i>tAA</i>	13.5 (13.125)5,11	20	ns		
ACT to internal read or write delay time	<i>tRCD</i>	13.5 (13.125)5,11	—	ns		
PRE command period	<i>tRP</i>	13.5 (13.125)5,11	—	ns		
ACT to ACT or REF command period	<i>tRC</i>	49.5 (49.125)5,11	—	ns		
ACT to PRE command period	<i>tRAS</i>	36	9 * tREFI	ns		
CL = 6	CWL = 5	<i>tCK(AVG)</i>	2.5	3.3	ns	1,2,3,7
	CWL = 6	<i>tCK(AVG)</i>	Reserved		ns	1,2,3,4,7
	CWL = 7	<i>tCK(AVG)</i>	Reserved		ns	4
CL = 7	CWL = 5	<i>tCK(AVG)</i>	Reserved		ns	4
	CWL = 6	<i>tCK(AVG)</i>	1.875	< 2.5	ns	1,2,3,4,7
			(Optional)5,11			
CWL = 7	<i>tCK(AVG)</i>	Reserved		ns	1,2,3,4	
CL = 8	CWL = 5	<i>tCK(AVG)</i>	Reserved		ns	4
	CWL = 6	<i>tCK(AVG)</i>	1.875	< 2.5	ns	1,2,3,7
	CWL = 7	<i>tCK(AVG)</i>	Reserved		ns	1,2,3,4
CL = 9	CWL = 5, 6	<i>tCK(AVG)</i>	Reserved		ns	4
	CWL = 7	<i>tCK(AVG)</i>	1.5	<1.875	ns	1,2,3,4
CL = 10	CWL = 5, 6	<i>tCK(AVG)</i>	Reserved		ns	4
	CWL = 7	<i>tCK(AVG)</i>	1.5	<1.875	ns	1,2,3
			(Optional)			
Supported CL Settings		6, 8, (7), 9, (10)		<i>nCK</i>		
Supported CWL Settings		5, 6, 7		<i>nCK</i>		

DDR3-1600 Speed Bins and Operating Conditions

Speed Bin		DDR3-1600		Unit	Note	
CL-nRCD-nRP		11-11-11				
Parameter	Symbol	min	max			
Internal read command to first data	<i>tAA</i>	13.75 (13.125)9	20	ns		
ACT to internal read or write delay time	<i>tRCD</i>	13.75 (13.125)9	—	ns		
PRE command period	<i>tRP</i>	13.75 (13.125)9	—	ns		
ACT to ACT or REF command period	<i>tRC</i>	48.75 (48.125)9	—	ns		
ACT to PRE command period	<i>tRAS</i>	35	9 * tREFI	ns		
CL = 6	CWL = 5	<i>tCK(AVG)</i>	2.5	3.3	ns	1,2,3,7
	CWL = 6	<i>tCK(AVG)</i>	Reserved		ns	1,2,3,4,7
	CWL = 7	<i>tCK(AVG)</i>	Reserved		ns	4
CL = 7	CWL = 5	<i>tCK(AVG)</i>	Reserved		ns	4
	CWL = 6	<i>tCK(AVG)</i>	1.875	< 2.5	ns	1,2,3,4,7
			(Optional)5,11			
CWL = 7	<i>tCK(AVG)</i>	Reserved		ns	1,2,3,4	
CL = 8	CWL = 5	<i>tCK(AVG)</i>	Reserved		ns	4

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Speed Bin		DDR3-1600		Unit	Note	
CL-nRCD-nRP		11-11-11				
Parameter	Symbol	min	max			
CL = 9	CWL = 6	<i>tCK(AVG)</i>	1.875	< 2.5	ns	1,2,3,7
	CWL = 7	<i>tCK(AVG)</i>	Reserved		ns	1,2,3,4
	CWL = 5, 6	<i>tCK(AVG)</i>	Reserved		ns	4
CL = 10	CWL = 7	<i>tCK(AVG)</i>	1.5	<1.875	ns	1,2,3,4
	CWL = 5, 6	<i>tCK(AVG)</i>	Reserved		ns	4
	CWL = 7	<i>tCK(AVG)</i>	1.5	<1.875	ns	1,2,3
CL = 11	CWL = 5, 6, 7	<i>tCK(AVG)</i>	Reserved		ns	4
	CWL = 8	<i>tCK(AVG)</i>	1.25	<1.5	ns	1,2,3,9
Supported CL Settings		6, 8, 7, 9, 10, 11		<i>nCK</i>		
Supported CWL Settings		5, 6, 7, 8		<i>nCK</i>		

DDR3-1866 Speed Bins and Operating Conditions

Speed Bin		DDR3-1866		Unit	Note	
CL-nRCD-nRP		13-13-13				
Parameter	Symbol	min	max			
Internal read command to first data	<i>tAA</i>	13.91 (13.125)10	20	ns		
ACT to internal read or write delay time	<i>tRCD</i>	13.91 (13.125)10	—	ns		
PRE command period	<i>tRP</i>	13.91 (13.125)10	—	ns		
ACT to ACT or REF command period	<i>tRC</i>	47.91 (47.125)10	—	ns		
ACT to PRE command period	<i>tRAS</i>	34	9 * tREFI	ns		
CL = 6	CWL = 5	<i>tCK(AVG)</i>	2.5	3.3	ns	1,2,3,8
	CWL = 6	<i>tCK(AVG)</i>	Reserved		ns	1,2,3,4,8
	CWL = 7,8,9	<i>tCK(AVG)</i>	Reserved		ns	4
CL = 7	CWL = 5	<i>tCK(AVG)</i>	Reserved		ns	4
	CWL = 6	<i>tCK(AVG)</i>	1.875	2.5	ns	1,2,3,4,8
	CWL = 7,8,9	<i>tCK(AVG)</i>	Reserved		ns	4
CL = 8	CWL = 5	<i>tCK(AVG)</i>	Reserved		ns	4
	CWL = 6	<i>tCK(AVG)</i>	1.875	< 2.5	ns	1,2,3,8
	CWL = 7	<i>tCK(AVG)</i>	Reserved		ns	1,2,3,4,8
	CWL = 8,9	<i>tCK(AVG)</i>	Reserved		ns	4
CL = 9	CWL = 5, 6	<i>tCK(AVG)</i>	Reserved		ns	4
	CWL = 7	<i>tCK(AVG)</i>	1.5	1.875	ns	1,2,3,4,8
	CWL = 8	<i>tCK(AVG)</i>	Reserved		ns	4
	CWL = 9	<i>tCK(AVG)</i>	Reserved		ns	4
CL = 10	CWL = 5, 6	<i>tCK(AVG)</i>	Reserved		ns	4
	CWL = 7	<i>tCK(AVG)</i>	1.5	<1.875	ns	1,2,3,8
	CWL = 8	<i>tCK(AVG)</i>	Reserved		ns	1,2,3,4,8
CL = 11	CWL = 5, 6, 7	<i>tCK(AVG)</i>	Reserved		ns	4
	CWL = 8	<i>tCK(AVG)</i>	1.25	1.5	ns	1,2,3,9

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Speed Bin		DDR3-1866		Unit	Note
CL-nRCD-nRP		13-13-13			
Parameter	Symbol	min	max		
CL = 12	CWL = 9	<i>tCK(AVG)</i>		ns	4
	CWL = 5, 6, 7, 8	<i>tCK(AVG)</i>		ns	4
	CWL = 9	<i>tCK(AVG)</i>		ns	1,2,3,4
CL = 13	CWL = 5, 6, 7, 8	<i>tCK(AVG)</i>		ns	4
	CWL = 9	1.071	<1.25	ns	1,2,3,9
Supported CL Settings		6, 7, 8, 9, 10, 11, 13		<i>nCK</i>	
Supported CWL Settings		5, 6, 7, 8, 9		<i>nCK</i>	

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Speed Bin Table Notes

1. Absolute Specification (TOPER; VDDQ = VDD = 1.35V (1.283 to 1.45V) & 1.5V (1.425 to 1.575V)
2. The CL setting and CWL setting result in tCK(AVG).MIN and tCK(AVG).MAX requirements. When making a selection of tCK(AVG), both need to be fulfilled: Requirements from CL setting as well as requirements from CWL setting.
3. tCK(AVG).MIN limits: Since CAS Latency is not purely analog - data and strobe output are synchronized by the DLL - all possible intermediate frequencies may not be guaranteed. An application should use the next smaller JEDEC standard tCK(AVG) value (3.0, 2.5, 1.875, 1.5, 1.25, 1.07, or 0.935 ns) when calculating $CL [nCK] = tAA [ns] / tCK(AVG) [ns]$, rounding up to the next 'Supported CL', where tCK(AVG) = 3.0 ns should only be used for CL = 5 calculation.
4. tCK(AVG).MAX limits: Calculate $tCK(AVG) = tAA.MAX / CL SELECTED$ and round the resulting tCK(AVG) down to the next valid speed bin (i.e. 3.3ns or 2.5ns or 1.875 ns or 1.5 ns or 1.25 ns or 1.07 ns or 0.935 ns). This result is tCK(AVG).MAX corresponding to CL SELECTED.
5. 'Reserved' settings are not allowed. User must program a different value.
6. 'Optional' settings allow certain devices in the industry to support this setting; however, it is not a mandatory feature. Refer to supplier's data sheet and/or the DIMM SPD information if and how this setting is supported.
7. Any DDR3-1066 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.
8. Any DDR3-1333 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.
9. Any DDR3-1866 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.
10. For devices supporting optional down binning to CL=7 and CL=9, tAA/tRCD/tRPmin must be 13.125 ns or lower. SPD settings must be programmed to match. For example, DDR3-1333H devices supporting down binning to DDR3-1066F should program 13.125 ns in SPD bytes for tAAmin (Byte 16), tRCDmin (Byte 18), and tRPmin (Byte 20). DDR3-1600K devices supporting down binning to DDR3-1333H or DDR3-1066F should program 13.125 ns in SPD bytes for tAAmin (Byte16), tRCDmin (Byte 18), and tRPmin (Byte 20). Once tRP (Byte 20) is programmed to 13.125ns, tRCmin (Byte 21, 23) also should be programmed accordingly. For example, 49.125ns (tRASmin + tRPmin = 36 ns + 13.125 ns) for DDR3-1333H and 48.125ns (tRASmin + tRPmin = 35 ns + 13.125 ns) for DDR3-1600K.
11. For devices supporting optional down binning to CL=11, CL=9 and CL=7, tAA/tRCD/tRPmin must be 13.125ns. SPD setting must be programmed to match. For example, DDR3-1866 devices supporting down binning to DDR3-1600 or DDR3-1333 or 1066 should program 13.125ns in SPD bytes for tAAmin(byte16), tRCDmin(Byte18) and tRPmin (byte20). Once tRP (Byte20) is programmed to 13.125ns, tRCmin (Byte21,23) also should be programmed accordingly. For example, 47.125ns (tRASmin + tRPmin = 34ns + 13.125ns)

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Timing Parameters

Parameter	Symbol	DDR3-800		DDR3-1066		DDR3-1333		Units	Note	
		MIN	MAX	MIN	MAX	MIN	MAX			
Clock Timing										
Minimum Clock Cycle Time (DLL off mode)	tCK(DLL_OF F)	8	-	8	-	8	-	ns	6	
Average Clock Period	tCK(avg)	See Speed Bins Table						ps		
Clock Period	tCK(abs)	tCK(avg)min + tJIT(per)min	tCK(avg)max + tJIT(per)max	tCK(avg)min + tJIT(per)min	tCK(avg)max + tJIT(per)max	tCK(avg)min + tJIT(per)min	tCK(avg)max + tJIT(per)max	ps		
Average high pulse width	tCH(avg)	0.47	0.53	0.47	0.53	0.47	0.53	tCK(avg)		
Average low pulse width	tCL(avg)	0.47	0.53	0.47	0.53	0.47	0.53	tCK(avg)		
Clock Period Jitter	tJIT(per)	-100	100	-90	90	-80	80	ps		
Clock Period Jitter during DLL locking period	tJIT(per, ick)	-90	90	-80	80	-70	70	ps		
Cycle to Cycle Period Jitter	tJIT(cc)	200		180		160		ps		
Cycle to Cycle Period Jitter during DLL locking period	tJIT(cc, ick)	180		160		140		ps		
Cumulative error across 2 cycles	tERR(2per)	- 147	147	- 132	132	- 118	118	ps		
Cumulative error across 3 cycles	tERR(3per)	- 175	175	- 157	157	- 140	140	ps		
Cumulative error across 4 cycles	tERR(4per)	- 194	194	- 175	175	- 155	155	ps		
Cumulative error across 5 cycles	tERR(5per)	- 209	209	- 188	188	- 168	168	ps		
Cumulative error across 6 cycles	tERR(6per)	- 222	222	- 200	200	- 177	177	ps		
Cumulative error across 7 cycles	tERR(7per)	- 232	232	- 209	209	- 186	186	ps		
Cumulative error across 8 cycles	tERR(8per)	- 241	241	- 217	217	- 193	193	ps		
Cumulative error across 9 cycles	tERR(9per)	- 249	249	- 224	224	- 200	200	ps		
Cumulative error across 10 cycles	tERR(10per)	- 257	257	- 231	231	- 205	205	ps		
Cumulative error across 11 cycles	tERR(11per)	- 263	263	- 237	237	- 210	210	ps		
Cumulative error across 12 cycles	tERR(12per)	- 269	269	- 242	242	- 215	215	ps		
Cumulative error across n = 13, 14 ... 49, 50 cycles	tERR(nper)	tERR(nper)min = (1 + 0.68ln(n))*tJIT(per)min tERR(nper)max = (1 + 0.68ln(n))*tJIT(per)max						ps	24	
Absolute clock HIGH pulse width	tCH(abs)	0.43	-	0.43	-	0.43	-	tCK(avg)	25	
Absolute clock Low pulse width	tCL(abs)	0.43	-	0.43	-	0.43	-	tCK(avg)	26	
Data Timing										
DQS, DQS to DQ skew, per group, per access	tDQSQ	-	200	-	150	-	125	ps	13	
DQ output hold time from DQS, DQS	tQH	0.38	-	0.38	-	0.38	-	tCK(avg)	13, g	
DQ low-impedance time from CK, CK	tLZ(DQ)	-800	400	-600	300	-500	250	ps	13,14, f	
DQ high-impedance time from CK, CK	tHZ(DQ)	-	400	-	300	-	250	ps	13,14, f	
Data setup time to DQS, DQS referenced to VIH(AC)VIL(AC) levels	tDS(base)	75	-	25	-	30	-	ps	d, 17	
Data hold time to DQS, DQS referenced to VIH(AC)VIL(AC) levels	tDH(base)	150	-	100	-	65	-	ps	d, 17	
DQ and DM Input pulse width for each input	tDIPW	600	-	490	-	400	-	ps	28	
Data Strobe Timing										
DQS, DQS READ Preamble	tRPRE	0.9	Note 19	0.9	Note 19	0.9	Note 19	tCK	13, 19, g	
DQS, DQS differential READ Postamble	tRPST	0.3	Note 11	0.3	Note 11	0.3	Note 11	tCK	11, 13, b	
DQS, DQS output high time	tQSH	0.38	-	0.38	-	0.4	-	tCK(avg)	13, g	
DQS, DQS output low time	tQSL	0.38	-	0.38	-	0.4	-	tCK(avg)	13, g	
DQS, DQS WRITE Preamble	tWPRE	0.9	-	0.9	-	0.9	-	tCK		
DQS, DQS WRITE Postamble	tWPST	0.3	-	0.3	-	0.3	-	tCK		
DQS, DQS rising edge output access time from rising CK, CK	tDQSCK	-400	400	-300	300	-255	255	ps	13, f	
DQS, DQS low-impedance time (Referenced from RL-1)	tLZ(DQS)	-800	400	-600	300	-500	250	ps	13,14, f	
DQS, DQS high-impedance time (Referenced from RL+BL/2)	tHZ(DQS)	-	400	-	300	-	250	ps	12,13,14	
DQS, DQS differential input low pulse width	tDQSL	0.45	0.55	0.45	0.55	0.45	0.55	tCK	29, 31	
DQS, DQS differential input high pulse width	tDQSH	0.45	0.55	0.45	0.55	0.45	0.55	tCK	30, 31	
DQS, DQS rising edge to CK, CK rising edge	tDQSS	-0.25	0.25	-0.25	0.25	-0.25	0.25	tCK(avg)	c	
DQS, DQS falling edge setup time to CK, CK rising edge	tDSS	0.2	-	0.2	-	0.2	-	tCK(avg)	c, 32	
DQS, DQS falling edge hold time to CK, CK rising edge	tDSH	0.2	-	0.2	-	0.2	-	tCK(avg)	c, 32	

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Timing Parameters (Cont.)

Speed Parameter	Symbol	DDR3-800		DDR3-1066		DDR3-1333		Units	Note	
		MIN	MAX	MIN	MAX	MIN	MAX			
Command and Address Timing										
DLL locking time	tDLLK	512	-	512	-	512	-	nCK		
internal READ Command to PRECHARGE Command delay	tRTP	max (4nCK,7.5ns)	-	max (4nCK,7.5ns)	-	max (4nCK,7.5ns)	-		e	
Delay from start of internal write transaction to internal read command	tWTR	max (4nCK,7.5ns)	-	max (4nCK,7.5ns)	-	max (4nCK,7.5ns)	-		e,18	
WRITE recovery time	tWR	15	-	15	-	15	-	ns	e	
Mode Register Set command cycle time	tMRD	4	-	4	-	4	-	nCK		
Mode Register Set command update delay	tMOD	max (12nCK,15ns)	-	max (12nCK,15ns)	-	max (12nCK,15ns)	-			
CAS# to CAS# command delay	tCCD	4	-	4	-	4	-	nCK		
Auto precharge write recovery + precharge time	tDAL(min)	WR + roundup (tRP / tCK(AVG))							nCK	
Multi-Purpose Register Recovery Time	tMPRR	1	-	1	-	1	-	nCK	22	
ACTIVE to PRECHARGE command period	tRAS	See 13.3 " Speed Bins and CL, tRCD, tRP, tRC and tRAS for corresponding Bin" on page 37							ns	e
ACTIVE to ACTIVE command period for 1KB page size	tRRD	max (4nCK,10ns)	-	max (4nCK,7.5ns)	-	max (4nCK,6ns)	-		e	
ACTIVE to ACTIVE command period for 2KB page size	tRRD	max (4nCK,10ns)	-	max (4nCK,10ns)	-	max (4nCK,7.5ns)	-		e	
Four activate window for 1KB page size	tFAW	40	-	37.5	-	30	-	ns	e	
Four activate window for 2KB page size	tFAW	50	-	50	-	45	-	ns	e	
Command and Address setup time to CK, CK referenced to VIH(AC) / VIL(AC) levels	tIS(base)	200	-	125	-	65	-	ps	b,16	
Command and Address hold time from CK, CK referenced to VIH(AC) / VIL(AC) levels	tIH(base)	275	-	200	-	140	-	ps	b,16	
Command and Address setup time to CK, CK referenced to VIH(AC) / VIL(AC) levels	tIS(base) AC150	200 + 150	-	125 + 150	-	65+125	-	ps	b,16,27	
Control & Address Input pulse width for each input	tIPW	900	-	780	-	620	-	ps	28	
Calibration Timing										
Power-up and RESET calibration time	tZQinitl	512	-	512	-	512	-	nCK		
Normal operation Full calibration time	tZQoper	256	-	256	-	256	-	nCK		
Normal operation short calibration time	tZQCS	64	-	64	-	64	-	nCK	23	
Reset Timing										
Exit Reset from CKE HIGH to a valid command	tXPR	max(5nCK, tRFC + 10ns)	-	max(5nCK, tRFC + 10ns)	-	max(5nCK, tRFC + 10ns)	-			
Self Refresh Timing										
Exit Self Refresh to commands not requiring a locked DLL	tXS	max(5nCK, tRFC + 10ns)	-	max(5nCK, tRFC + 10ns)	-	max(5nCK, tRFC + 10ns)	-			
Exit Self Refresh to commands requiring a locked DLL	tXSDLL	tDLLK(min)	-	tDLLK(min)	-	tDLLK(min)	-	nCK		
Minimum CKE low width for Self refresh entry to exit timing	tCKESR	tCKE(min) + 1tCK	-	tCKE(min) + 1tCK	-	tCKE(min) + 1tCK	-			
Valid Clock Requirement after Self Refresh Entry (SRE) or Power-Down Entry (PDE)	tCKSRE	max(5nCK, 10ns)	-	max(5nCK, 10ns)	-	max(5nCK, 10ns)	-			
Valid Clock Requirement before Self Refresh Exit (SRX) or Power-Down Exit (PDX) or Reset Exit	tCKSRX	max(5nCK, 10ns)	-	max(5nCK, 10ns)	-	max(5nCK, 10ns)	-			

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Timing Parameters(Cont.)

Speed		DDR3-800		DDR3-1066		DDR3-1333		Units	Note
Parameter	Symbol	MIN	MAX	MIN	MAX	MIN	MAX		
Power Down Timing									
Exit Power Down with DLL on to any valid command; Exit Precharge Power Down with DLL frozen to commands not requiring a locked DLL	tXP	max (3nCK, 7.5ns)	-	max (3nCK, 7.5ns)	-	max (3nCK, 6ns)	-		
Exit Precharge Power Down with DLL frozen to commands requiring a locked DLL	tXPDLL	max (10nCK, 24ns)	-	max (10nCK, 24ns)	-	max (10nCK, 24ns)	-		2
CKE minimum pulse width	tCKE	max (3nCK, 7.5ns)	-	max (3nCK, 5.625ns)	-	max (3nCK, 5.625ns)	-		
Command pass disable delay	tCPDED	1	-	1	-	1	-	nCK	
Power Down Entry to Exit Timing	tPD	tCKE(min)	9*tREFI	tCKE(min)	9*tREFI	tCKE(min)	9*tREFI	tCK	15
Timing of ACT command to Power Down entry	tACTPDEN	1	-	1	-	1	-	nCK	20
Timing of PRE command to Power Down entry	tPRPDEN	1	-	1	-	1	-	nCK	20
Timing of RD/RDA command to Power Down entry	tRDPDEN	RL + 4 + 1	-	RL + 4 + 1	-	RL + 4 + 1	-		
Timing of WR command to Power Down entry (BL8OTF, BL8MRS, BL4OTF)	tWRPDEN	WL + 4 +(tWR/ tCK(avg))	-	WL + 4 +(tWR/ tCK(avg))	-	WL + 4 +(tWR/ tCK(avg))	-	nCK	9
Timing of WRA command to Power Down entry (BL8OTF, BL8MRS, BL4OTF)	tWRAPDEN	WL + 4 +WR + 1	-	WL + 4 +WR + 1	-	WL + 4 +WR + 1	-	nCK	10
Timing of WR command to Power Down entry (BL4MRS)	tWRPDEN	WL + 2 +(tWR/ tCK(avg))	-	WL + 2 +(tWR/ tCK(avg))	-	WL + 2 +(tWR/ tCK(avg))	-	nCK	9
Timing of WRA command to Power Down entry (BL4MRS)	tWRAPDEN	WL + 2 +WR + 1	-	WL + 2 +WR + 1	-	WL + 2 +WR + 1	-	nCK	10
Timing of REF command to Power Down entry	tREFPDEN	1	-	1	-	1	-		20,21
Timing of MRS command to Power Down entry	tMRSPDEN	tMOD(min)	-	tMOD(min)	-	tMOD(min)	-		
ODT Timing									
ODT high time without write command or with write command and BC4	ODTH4	4	-	4	-	4	-	nCK	
ODT high time with Write command and BL8	ODTH8	6	-	6	-	6	-	nCK	
Asynchronous RTT turn-on delay (Power-Down with DLL frozen)	tAONPD	2	8.5	2	8.5	2	8.5	ns	
Asynchronous RTT turn-off delay (Power-Down with DLL frozen)	tAOFPD	2	8.5	2	8.5	2	8.5	ns	
ODT turn-on	tAON	-400	400	-300	300	-250	250	ps	7,f
RTT_NOM and RTT_WR turn-off time from ODTLoff reference	tAOF	0.3	0.7	0.3	0.7	0.3	0.7	tCK(avg)	8,f
RTT dynamic change skew	tADC	0.3	0.7	0.3	0.7	0.3	0.7	tCK(avg)	f
Write Leveling Timing									
First DQS pulse rising edge after tDQSS margining mode is programmed	tWLMRD	40	-	40	-	40	-	tCK	3
DQS/DQS delay after tDQSS margining mode is programmed	tWLDQSEN	25	-	25	-	25	-	tCK	3
Setup time for tDQSS latch	tWLS	325	-	245	-	195	-	ps	
Write leveling hold time from rising DQS, DQS crossing to rising CK, CK crossing	tWLH	325	-	245	-	195	-	ps	
Write leveling output delay	tWLO	0	9	0	9	0	9	ns	
Write leveling output error	tWLOE	0	2	0	2	0	2	ns	

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Timing Parameters

Parameter	Symbol	DDR3-1600		DDR3-1866		Units	Note
		MIN	MAX	MIN	MAX		
Clock Timing							
Minimum Clock Cycle Time (DLL off mode)	tCK(DLL_OF F)	8	-	8	-	ns	6
Average Clock Period	tCK(avg)	See Speed Bins Table				ps	
Clock Period	tCK(abs)	tCK(avg)min + tJIT(per)min	tCK(avg)max + tJIT(per)max	tCK(avg)min + tJIT(per)min	tCK(avg)max + tJIT(per)max	ps	
Average high pulse width	tCH(avg)	0.47	0.53	0.47	0.53	tCK(avg)	
Average low pulse width	tCL(avg)	0.47	0.53	0.47	0.53	tCK(avg)	
Clock Period Jitter	tJIT(per)	-70	70	-60	60	ps	
Clock Period Jitter during DLL locking period	tJIT(per, lck)	-60	60	-50	50	ps	
Cycle to Cycle Period Jitter	tJIT(cc)	140		120		ps	
Cycle to Cycle Period Jitter during DLL locking period	tJIT(cc, lck)	120		100		ps	
Cumulative error across 2 cycles	tERR(2per)	- 103	103	- 88	88	ps	
Cumulative error across 3 cycles	tERR(3per)	- 122	122	- 105	105	ps	
Cumulative error across 4 cycles	tERR(4per)	- 136	136	- 117	117	ps	
Cumulative error across 5 cycles	tERR(5per)	- 147	147	- 126	126	ps	
Cumulative error across 6 cycles	tERR(6per)	- 155	155	- 133	133	ps	
Cumulative error across 7 cycles	tERR(7per)	- 163	163	- 139	139	ps	
Cumulative error across 8 cycles	tERR(8per)	- 169	169	- 145	145	ps	
Cumulative error across 9 cycles	tERR(9per)	- 175	175	- 150	150	ps	
Cumulative error across 10 cycles	tERR(10per)	- 180	180	- 154	154	ps	
Cumulative error across 11 cycles	tERR(11per)	- 184	184	- 158	158	ps	
Cumulative error across 12 cycles	tERR(12per)	- 188	188	- 161	161	ps	
Cumulative error across n = 13, 14 ... 49, 50 cycles	tERR(nper)	tERR(nper)min = (1 + 0.68ln(n))*tJIT(per)min tERR(nper)max = (1 + 0.68ln(n))*tJIT(per)max				ps	24
Absolute clock HIGH pulse width	tCH(abs)	0.43	-	0.43	-	tCK(avg)	25
Absolute clock Low pulse width	tCL(abs)	0.43	-	0.43	-	tCK(avg)	26
Data Timing							
DQS, DQS to DQ skew, per group, per access	tDQSQ	-	100	-	85	ps	13
DQ output hold time from DQS, DQS	tQH	0.38	-	0.38	-	tCK(avg)	13, g
DQ low-impedance time from CK, CK	tLZ(DQ)	-450	225	-390	195	ps	13,14, f
DQ high-impedance time from CK, CK	tHZ(DQ)	-	225	-	195	ps	13,14, f
Data setup time to DQS, DQS referenced to VIH(AC)VIL(AC) levels	tDS(base)	10	-	-	-	ps	d, 17
Data hold time to DQS, DQS referenced to VIH(AC)VIL(AC) levels	tDH(base)	-	-	0	-	ps	d, 17
DQ and DM Input pulse width for each input	tDIPW	360	-	320	-	ps	28
Data Strobe Timing							
DQS, DQS READ Preamble	tRPRE	0.9	Note 19	0.9	Note 19	tCK	13, 19, g
DQS, DQS differential READ Postamble	tRPST	0.3	Note 11	0.3	Note 11	tCK	11, 13, b
DQS, DQS output high time	tQSH	0.4	-	0.4	-	tCK(avg)	13, g
DQS, DQS output low time	tQSL	0.4	-	0.4	-	tCK(avg)	13, g
DQS, DQS WRITE Preamble	tWPRE	0.9	-	0.9	-	tCK	
DQS, DQS WRITE Postamble	tWPST	0.3	-	0.3	-	tCK	
DQS, DQS rising edge output access time from rising CK, CK	tDQSCK	-225	225	-195	195	ps	13, f
DQS, DQS low-impedance time (Referenced from RL-1)	tLZ(DQS)	-450	225	-390	195	ps	13,14, f
DQS, DQS high-impedance time (Referenced from RL+BL/2)	tHZ(DQS)	-	225	-	195	ps	12,13,14
DQS, DQS differential input low pulse width	tDQSL	0.45	0.55	0.45	0.55	tCK	29, 31
DQS, DQS differential input high pulse width	tDQSH	0.45	0.55	0.45	0.55	tCK	30, 31
DQS, DQS rising edge to CK, CK rising edge	tDQSS	-0.27	0.27	-0.27	0.27	tCK(avg)	c
DQS, DQS falling edge setup time to CK, CK rising edge	tDSS	0.9	Note 19	0.18	-	tCK(avg)	c, 32
DQS, DQS falling edge hold time to CK, CK rising edge	tDSH	0.3	Note 11	0.18	-	tCK(avg)	c, 32

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Timing Parameters (Cont.)

Speed	Parameter	Symbol	DDR3-1600		DDR3-1866				Units	Note		
			MIN	MAX	MIN	MAX	MIN	MAX				
Command and Address Timing												
	DLL locking time	tDLLK	512	-	512	-			nCK			
	internal READ Command to PRECHARGE Command delay	tRTP	max (4nCK,7.5ns)	-	max (4nCK,7.5ns)	-				e		
	Delay from start of internal write transaction to internal read command	tWTR	max (4nCK,7.5ns)	-	max (4nCK,7.5ns)	-				e,18		
	WRITE recovery time	tWR	15	-	15	-			ns	e		
	Mode Register Set command cycle time	tMRD	4	-	4	-			nCK			
	Mode Register Set command update delay	tMOD	max (12nCK,15ns)	-	max (12nCK,15ns)	-						
	CAS# to CAS# command delay	tCCD	4	-	4	-			nCK			
	Auto precharge write recovery + precharge time	tDAL(min)	WR + roundup (tRP / tCK(AVG))							nCK		
	Multi-Purpose Register Recovery Time	tMPRR	1	-	1	-			nCK	22		
	ACTIVE to PRECHARGE command period	tRAS	See * Speed Bins and CL, tRCD, tRP, tRC and tRAS for corresponding Bin*								ns	e
	ACTIVE to ACTIVE command period for 1KB page size	tRRD	max (4nCK,6ns)	-	max (4nCK,5ns)	-				e		
	ACTIVE to ACTIVE command period for 2KB page size	tRRD	max (4nCK,7.5ns)	-	max (4nCK,6ns)	-				e		
	Four activate window for 1KB page size	tFAW	30	-	27	-			ns	e		
	Four activate window for 2KB page size	tFAW	40	-	35	-			ns	e		
	Command and Address setup time to CK, CK referenced to VIH(AC) / VIL(AC) levels	tIS(base)	170	-	-	-			ps	b,16		
	Command and Address hold time from CK, CK referenced to VIH(AC) / VIL(AC) levels	tIH(base)	120	-	100	-			ps	b,16		
	Command and Address setup time to CK, CK referenced to VIH(AC) / VIL(AC) levels	tIS(base) AC150	-	-	-	-			ps	b,16,27		
	Control & Address Input pulse width for each input	tIPW	560	-	535	-			ps	28		
Calibration Timing												
	Power-up and RESET calibration time	tZQinitl	512	-	Max(512nCK,640ns)	-			nCK			
	Normal operation Full calibration time	tZQoper	256	-	Max(256nCK,320ns)	-			nCK			
	Normal operation short calibration time	tZQCS	64	-	Max(64nCK,80ns)	-			nCK	23		
Reset Timing												
	Exit Reset from CKE HIGH to a valid command	tXPR	max(5nCK, tRFC + 10ns)	-	max(5nCK, tRFC + 10ns)	-	max(5nCK, tRFC + 10ns)	-				
Self Refresh Timing												
	Exit Self Refresh to commands not requiring a locked DLL	tXS	max(5nCK, tRFC + 10ns)	-	max(5nCK, tRFC + 10ns)	-	max(5nCK, tRFC + 10ns)	-				
	Exit Self Refresh to commands requiring a locked DLL	tXSDLL	tDLLK(min)	-	tDLLK(min)	-	tDLLK(min)	-	nCK			
	Minimum CKE low width for Self refresh entry to exit timing	tCKESR	tCKE(min) + 1tCK	-	tCKE(min) + 1tCK	-	tCKE(min) + 1tCK	-				
	Valid Clock Requirement after Self Refresh Entry (SRE) or Power-Down Entry (PDE)	tCKSRE	max(5nCK, 10ns)	-	max(5nCK, 10ns)	-	max(5nCK, 10ns)	-				
	Valid Clock Requirement before Self Refresh Exit (SRX) or Power-Down Exit (PDX) or Reset Exit	tCKSRX	max(5nCK, 10ns)	-	max(5nCK, 10ns)	-	max(5nCK, 10ns)	-				

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Timing Parameters(Cont.)

Speed		DDR3-1600		DDR3-1866				Units	Note
Parameter	Symbol	MIN	MAX	MIN	MAX	MIN	MAX		
Power Down Timing									
Exit Power Down with DLL on to any valid command; Exit Precharge Power Down with DLL frozen to commands not requiring a locked DLL	tXP	max (3nCK, 6ns)	-	max (3nCK, 6ns)	-				
Exit Precharge Power Down with DLL frozen to commands requiring a locked DLL	tXPDLL	max (10nCK, 24ns)	-	max (10nCK, 24ns)	-				2
CKE minimum pulse width	tCKE	max (3nCK, 5ns)	-	max (3nCK, 5ns)	-				
Command pass disable delay	tCPDED	1	-	1	-			nCK	
Power Down Entry to Exit Timing	tPD	tCKE(min)	9*tREFI	tCKE(min)	9*tREFI			tCK	15
Timing of ACT command to Power Down entry	tACTPDEN	1	-	1	-			nCK	20
Timing of PRE command to Power Down entry	tPRPDEN	1	-	1	-			nCK	20
Timing of RD/RDA command to Power Down entry	tRDPDEN	RL + 4 + 1	-	RL + 4 + 1	-				
Timing of WR command to Power Down entry (BL8OTF, BL8MRS, BL4OTF)	tWRPDEN	WL + 4 +(tWR/ tCK(avg))	-	WL + 4 +(tWR/ tCK(avg))	-			nCK	9
Timing of WRA command to Power Down entry (BL8OTF, BL8MRS, BL4OTF)	tWRAPDEN	WL + 4 +WR + 1	-	WL + 4 +WR + 1	-			nCK	10
Timing of WR command to Power Down entry (BL4MRS)	tWRPDEN	WL + 2 +(tWR/ tCK(avg))	-	WL + 2 +(tWR/ tCK(avg))	-			nCK	9
Timing of WRA command to Power Down entry (BL4MRS)	tWRAPDEN	WL + 2 +WR + 1	-	WL + 2 +WR + 1	-			nCK	10
Timing of REF command to Power Down entry	tREFPDEN	1	-	1	-				20,21
Timing of MRS command to Power Down entry	tMRSPDEN	tMOD(min)	-	tMOD(min)	-				
ODT Timing									
ODT high time without write command or with write command and BC4	ODTH4	4	-	4	-			nCK	
ODT high time with Write command and BL8	ODTH8	6	-	6	-			nCK	
Asynchronous RTT turn-on delay (Power-Down with DLL frozen)	tAONPD	2	8.5	2	8.5			ns	
Asynchronous RTT turn-off delay (Power-Down with DLL frozen)	tAOFDP	2	8.5	2	8.5			ns	
ODT turn-on	tAON	-225	225	-195	195			ps	7,f
RTT_NOM and RTT_WR turn-off time from ODTLoff reference	tAOF	0.3	0.7	0.3	0.7			tCK(avg)	8,f
RTT dynamic change skew	tADC	0.3	0.7	0.3	0.7			tCK(avg)	f
Write Leveling Timing									
First DQS pulse rising edge after tDQSS margining mode is programmed	tWLMRD	40	-	40	-			tCK	3
DQS/DQS delay after tDQSS margining mode is programmed	tWLDQSEN	25	-	25	-			tCK	3
Setup time for tDQSS latch	tWLS	165	-	140	-			ps	
Write leveling hold time from rising DQS, DQS crossing to rising CK, CK crossing	tWLH	165	-	140	-			ps	
Write leveling output delay	tWLO	0	7.5	0	7.5			ns	
Write leveling output error	tWLOE	0	2	0	2			ns	

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18.1 Jitter Notes

1. Unit 'tCK(avg)' represents the actual tCK(avg) of the input clock under operation. Unit 'nCK' represents one clock cycle of the input clock, counting the actual clock edges. ex) tMRD = 4 [nCK] means; if one Mode Register Set command is registered at Tm, another Mode Register Set command may be registered at Tm+4, even if (Tm+4 - Tm) is 4 x tCK(avg) + tERR(4per),min.
2. These parameters are measured from a command/address signal (CKE, CS, RAS, CAS, WE, ODT, BA0, A0, A1, etc.) transition edge to its respective clock signal (CK/CK) crossing. The spec values are not affected by the amount of clock jitter applied (i.e. tJIT(per), tJIT(cc), etc.), as the setup and hold are relative to the clock signal crossing that latches the command/address. That is, these parameters should be met whether clock jitter is present or not.
3. These parameters are measured from a data strobe signal (DQS(L/U), DQS(L/U)) crossing to its respective clock signal (CK, CK) crossing. The spec values are not affected by the amount of clock jitter applied (i.e. tJIT(per), tJIT(cc), etc.), as these are relative to the clock signal crossing. That is, these parameters should be met whether clock jitter is present or not.
4. These parameters are measured from a data signal (DM(L/U), DQ(L/U)0, DQ(L/U)1, etc.) transition edge to its respective data strobe signal (DQS(L/U), DQS(L/U)#) crossing. Specific Note e For these parameters, the DDR3 SDRAM device supports tnPARAM [nCK] = RU{ tPARAM [ns] / tCK(avg) [ns] }, which is in clock cycles, assuming all input clock jitter specifications are satisfied. For example, the device will support tnRP = RU{tRP / tCK(avg)}, which is in clock cycles, if all input clock jitter specifications are met. This means: For DDR3-800 6-6-6, of which tRP = 15ns, the device will support tnRP = RU{tRP / tCK(avg)} = 6, as long as the input clock jitter specifications are met, i.e. Precharge command at Tm and Active command at Tm+6 is valid even if (Tm+6 - Tm) is less than 15ns due to input clock jitter.
5. When the device is operated with input clock jitter, this parameter needs to be derated by the actual tERR(mper),act of the input clock, where 2 <= m <= 12. (output deratings are relative to the SDRAM input clock.) For example, if the measured jitter into a DDR3-800 SDRAM has tERR(mper),act,min = - 172 ps and tERR(mper),act,max = + 193 ps, then tDQSCK,min(derated) = tDQSCK,min - tERR(mper),act,max = - 400 ps - 193 ps = - 593 ps and tDQSCK,max(derated) = tDQSCK,max - tERR(mper),act,min = 400 ps + 172 ps = + 572 ps. Similarly, tLZ(DQ) for DDR3-800 derates to tLZ(DQ),min(derated) = 800 ps - 193 ps = - 993 ps and tLZ(DQ),max(derated) = 400 ps + 172 ps = + 572 ps. (Caution on the min/max usage!) Note that tERR(mper),act,min is the minimum measured value of tERR(nper) where 2 <= n <= 12, and tERR(mper),act,max is the maximum measured value of tERR(nper) where 2 <= n <= 12.
6. When the device is operated with input clock jitter, this parameter needs to be derated by the actual tJIT(per),act of the input clock. (output deratings are relative to the SDRAM input clock.) For example, if the measured jitter into a DDR3-800 SDRAM has tCK(avg),act = 2500 ps, tJIT(per),act,min = - 72 ps and tJIT(per),act,max = + 93 ps, then tRPRE,min(derated) = tRPRE,min + tJIT(per),act,min = 0.9 x tCK(avg),act + tJIT(per),act,min = 0.9 x 2500 ps - 72 ps = + 2178 ps. Similarly, tQH,min(derated) = tQH,min + tJIT(per),act,min = 0.38 x tCK(avg),act + tJIT(per),act,min = 0.38 x 2500 ps - 72 ps = + 878 ps. (Caution on the min/max usage!)= 0.38 x 2500 ps - 72 ps = + 878 ps. (Caution on the min/max usage!)

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18.2 Timing Parameter Notes

1. Actual value dependant upon measurement level definitions which are TBD.
2. Commands requiring a locked DLL are: READ (and RAP) and synchronous ODT commands.
3. The max values are system dependent.
4. WR as programmed in mode register
5. Value must be rounded-up to next higher integer value
6. There is no maximum cycle time limit besides the need to satisfy the refresh interval, tREFI.
7. For definition of RTT turn-on time tAON see "Device Operation"
8. For definition of RTT turn-off time tAOF see "Device Operation".
9. tWR is defined in ns, for calculation of tWRPDEN it is necessary to round up tWR / tCK to the next integer.
10. WR in clock cycles as programmed in MR0
11. The maximum read postamble is bound by tDQSK(min) plus tQSH(min) on the left side and tHZ(DQS)max on the right side. Device Operation.
12. Output timing deratings are relative to the SDRAM input clock. When the device is operated with input clock jitter, this parameter needs to be derated by TBD
13. Value is valid for RON34
14. Single ended signal parameter.
15. tREFI depends on TOPER
16. tIS(base) and tIH(base) values are for 1V/ns CMD/ADD single-ended slew rate and 2V/ns CK, CK differential slew rate, Note for DQ and DM signals, VREF(DC) = VREFDQ(DC). For input only pins except RESET, VREF(DC)=VREFCA(DC). See "Address/ Command Setup, Hold and Derating"
17. tDS(base) and tDH(base) values are for 1V/ns DQ single-ended slew rate and 2V/ns DQS, DQS differential slew rate. Note for DQ and DM signals, VREF(DC)= VREFDQ(DC). For input only pins except RESET, VREF(DC)=VREFCA(DC). See "Data Setup, Hold and Slew Rate Derating"
18. Start of internal write transaction is defined as follows ;
For BL8 (fixed by MRS and on-the-fly) : Rising clock edge 4 clock cycles after WL.
For BC4 (on-the-fly) : Rising clock edge 4 clock cycles after WL
For BC4 (fixed by MRS) : Rising clock edge 2 clock cycles after WL
19. The maximum read preamble is bound by tLZDQS(min) on the left side and tDQSK(max) on the right side. See "Device Operation"
20. CKE is allowed to be registered low while operations such as row activation, precharge, autoprecharge or refresh are in progress, but power-down IDD spec will not be applied until finishing those operations.
21. Although CKE is allowed to be registered LOW after a REFRESH command once tREFPDEN(min) is satisfied, there are cases where additional time such as tXPDLL(min) is also required. See "Device Operation".
22. Defined between end of MPR read burst and MRS which reloads MPR or disables MPR function.
23. One ZQCS command can effectively correct a minimum of 0.5 % (ZQCorrection) of RON and RTT impedance error within 64 nCK for all speed bins assuming the maximum sensitivities specified in the 'Output Driver Voltage and Temperature Sensitivity' and 'ODT Voltage and Temperature Sensitivity' tables. The appropriate interval between ZQCS commands can be determined from these tables and other application specific parameters. One method for calculating the interval between ZQCS commands, given the temperature (Tdriftrate) and voltage (Vdriftrate) drift rates that the SDRAM is subject to in the application, is illustrated. The interval could be defined by the following formula:

$$\frac{ZQCorrection}{(TSens \times Tdriftrate) + (VSens \times Vdriftrate)}$$

where TSens = max(dRTTdT, dRONdTM) and VSens = max(dRTTdV, dRONdVM) define the SDRAM temperature and voltage sensitivities.

For example, if TSens = 1.5% /°C, VSens = 0.15% / mV, Tdriftrate = 1°C / sec and Vdriftrate = 15 mV / sec, then the interval between ZQCS commands is calculated as:

$$\frac{0.5}{(1.5 \times 1) + (0.15 \times 15)} = 0.133 \sim 128\text{ms}$$

24. n = from 13 cycles to 50 cycles. This row defines 38 parameters.
25. tCH(abs) is the absolute instantaneous clock high pulse width, as measured from one rising edge to the following falling edge.
26. tCL(abs) is the absolute instantaneous clock low pulse width, as measured from one falling edge to the following rising edge.
27. The tIS(base) AC150 specifications are adjusted from the tIS(base) specification by adding an additional 100 ps of derating to accommodate for the lower alternate threshold of 150 mV and another 25 ps to account for the earlier reference point [(175 mv - 150 mV) / 1 V/ns].
28. Pulse width of a input signal is defined as the width between the first crossing of VREF(DC) and the consecutive crossing of VREF(DC)
29. tDQSL describes the instantaneous differential input low pulse width on DQS-DQS, as measured from one falling edge to the next consecutive rising edge.
30. tDQSH describes the instantaneous differential input high pulse width on DQS-DQS, as measured from one rising edge to the next consecutive falling edge.
31. tDQSH, act + tDQSL, act = 1 tCK, act ; with tXYZ, act being the actual measured value of the respective timing parameter in the application.
32. tDSH, act + tDSS, act = 1 tCK, act ; with tXYZ, act being the actual measured value of the respective timing parameter in the application.

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REVISION HISTORY

Revision	Release Date	Description of Change	Checked By (Full Name)
X1	October 15, 2009	Preliminary release	Brian Ouellette
X2	January 19, 2010	Add AC tables	Brian Ouellette
X3	October 28, 2010	Correct TDQS, TDQS# pin description	Brian Ouellette
A	December 22, 2010	Added 16GB Modules, remove preliminary mark	Brian Ouellette
B	November 2, 2011	Add 1600MT/S PN's IDD values, capacitance and timings based on 2rank PCB1232. Revised footer and header for new logo and company name. Add 4Gbit based PN's IDD values based on 2rank and 4rank.	
B1	August 22, 2012	Add 1600MT/S PN's IDD values, capacitance and timings based on 1rank PCB1251. Add 4Gbit based PN's IDD values.	
B2	June 20, 2013	Revised mechanical drawing to show dimension in mm and a nominal thickness with tolerance. add 1866MT/s 2Rx4 PN's and IDD table and speed bin. Updated DDP module thickness.	
B3	November 20, 2013	Revised PN table	
B4	December 12, 2013	Revised the tRFC for 4Gb from 300ns to 260ns	Chanhee Park
C	September 04, 2014	Add features note that module is backward compatible with 1.5V DDR3 DIMMs. Update DC OPERATING CONDITIONS AND CHARACTERISTICS table for 1.5V (B5, August 05, 2014)	
D	August 16, 2016	Add 32GB PN's using DDP	
E	June 23, 2017	Revise logo and address	

STATEMENT OF COMPLIANCE

Viking Technology(tm), Sanmina Corporation ("Viking") shall use commercially reasonable efforts to provide components, parts, materials, products and processes to Customer that do not contain: (i) lead, mercury, hexavalent chromium, polybrominated biphenyls (PBB) and polybrominated diphenyl ethers (PBDE) above 0.1% by weight in homogeneous material or (ii) cadmium above 0.01% by weight of homogeneous material, except as provided in any exemption(s) from RoHS requirements (including the most current version of the "Annex" to Directive 2002/95/EC of 27 January, 2003), as codified in the specific laws of the EU member countries. Viking strives to obtain appropriate contractual protections from its suppliers in connection with the RoHS Directives.

All printed circuit boards (PCBs) have a flammability rating of UL94V-0.

**Viking Technology ♦ 2950 Red Hill Ave ♦ Costa Mesa, CA 92626
Office: 714.913.2200 Fax: 714.913.2202 ♦ Website: <http://www.vikingtechnology.com>**

This Data Sheet is subject to change without notice.
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